



EV-DO-ATS

EV-DO Automatic Test System

User Manual

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1. Introduction

1.1. Overview

The EV-DO Automatic Test System (EV-DO ATS) provides an integrated test solution for evaluating parametric performance of EV-DO Access Terminals. The EV-DO ATS consists of an SR5500 Wireless Channel Emulator, one to three Agilent 8960 Base Station Emulator (S) , two AirAccess 3452 units, one 3462, two Agilent ESCs, and essential CDMA test equipment.

TestDrive EV-DO software automates EV-DO testing by configuring the instruments, stepping through the test sequences, and logging the results. By making most of the test setup and configuration automated, EV-DO ATS solves the following testing issues:

- Choosing the correct instruments and necessary system hardware.
- Translating the test standards into instrument settings.
- Writing software to automate test sequences.
- Logging test results.
- Reproducing test setups.

EV-DO ATS allows wireless service providers and equipment manufacturers and developers to evaluate Wireless Data Access products relative to industry-standard test requirements and user-defined test conditions.

1.1.1. *Product Highlights*

EV-DO ATS meets and exceeds industry standards for EV-DO testing.

EV-DO test specifications require the performance of EV-DO Terminals be evaluated over a variety of propagation and interference environments. To perform these tests, a system that emulates the essential propagation and interference conditions is required. In addition, these test beds require additional functions such as system control and configuration, RF power measurement, and level control.

EV-DO ATS combines all elements required for these tests into one integrated system for 3GPP2 C.S0033 Rev B (TIA-866) AT-MPS tests, as well as TIA-866 based receive diversity tests. When controlled by TestDrive EV-DO, the EV-DO ATS automatically executes these Access Terminal tests and logs test results.

TestDrive EV-DO provides the ability to begin running automatic performance tests in a matter of minutes.

TestDrive EV-DO provides an easy-to-use graphical user interface for automating Data Access Terminal tests. Pre-defined tests taken from industry standards can be loaded and running in minutes. This comprehensive software also facilitates creation of custom test conditions to find the performance limits of the device under test. Whether running pre-defined or custom tests, all results are logged in a Microsoft Access database. The EV-DO built-in results viewer allows you to view and print results in a variety of standard formats.

EV-DO ATS is based on advanced Spirent Communications emulation instruments.

Every EV-DO ATS includes the Spirent Wireless Channel Emulator (SR5500) with AWGN, and the TAS5048 and SR5068 Test Configuration Unit (TCU). These instruments provide the most integrated and powerful solutions available for evaluating Data Access Terminal receiver performance.

The Spirent Wireless Channel Emulator implements a superset of all RF channel conditions required for AT-MPS standard receiver testing, such as multi-path fading, delay spread, and path loss as well as Additive Gaussian White Noise (AWGN). Dynamic 3GPP channel models characterize rake receiver performance.

The TAS5048 and SR5068 Test Configuration Units are controlled by TestDrive EV-DO to automatically select from a list of pre-defined test configurations. For systems integrated with the Spirent LTE test solutions, the SR8048 and SR8068 are also supported. These instruments eliminate the need to manually configure the system, optimizing test execution speed.

1.1.2. EV-DO ATS Applications

EV-DO ATS yields thorough testing of EV-DO devices in a laboratory setting. This gives accurate and repeatable test results, allowing you to detect, isolate, and correct performance problems in the shortest possible time. EV-DO ATS eliminates the need for expensive, labor-intensive test systems and can drastically reduce the time spent doing field tests whose conditions cannot be controlled or repeated. Applications for EV-DO ATS include:

- Product Development
- Design Verification
- Product Qualification
- Conformance Test
- Competitive Analysis
- Performance Analysis

1.2. Theory of Operation

EV-DO ATS is a complete, integrated system for evaluating the performance of EV-DO Access Terminals. This system includes all the test instruments and control software required to accurately emulate the bi-directional end-to-end connection between the base station emulator and access terminal under test. An overview of the network model is shown in Figure 1-1.

1.2.1. Base Station to Access Terminal Network Model

The Base Station – Access Terminal connection is an RF link as shown below. The Base Station to Access Terminal link is considered the **Forward Channel**. Conversely, the Access Terminal to Base Station link is termed the **Reverse Channel**. The Forward and Reverse Channels operate at independent carrier frequencies. They transport data, and signaling information between the Base Station and Access Terminal by means of a spread spectrum carrier.

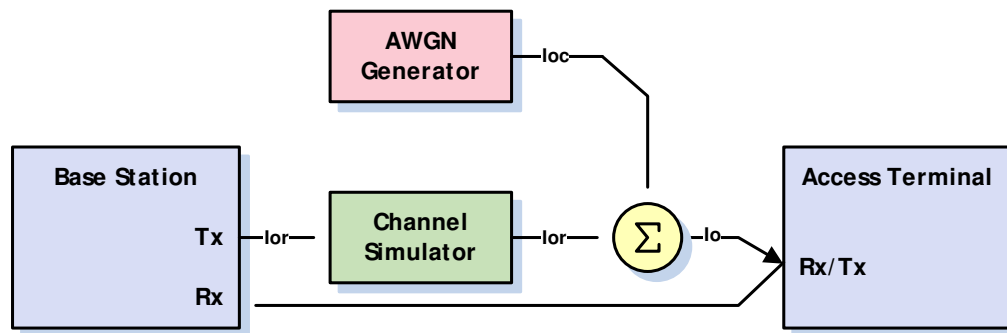


Figure 1-1: Access Terminal - Base Station Network Model
for Demodulation of the Forward Channel with Fading and Noise

Typically, when assessing the performance of access terminals, the Forward Channel is impaired while the Reverse Channel is left uncorrupted. This is done in order to evaluate the access terminal's ability to demodulate the transmit signal from the base station under adverse conditions. Industry standards require the access terminal to be characterized under the influence of multi-path propagation effects as well as additive co-channel and adjacent channel interference. Co-channel interference is approximated by Additive White Gaussian Noise (AWGN) while Continuous Waveform (CW) signals are utilized to act as adjacent channel interferers.

Test standards define typical propagation channel models which range from one to three paths. Each path undergoes Rayleigh fading and, for models with multiple paths, relative path-to-path delay and attenuation are also specified. A typical test model involving fading is shown in Figure 1-1.

Due to frequency re-use requirements, signals transmitted in nearby cells propagate beyond their own cell boundaries and interfere with the signal reception in bordering cells resulting in co-channel interference. To emulate these interference conditions, test standards require various levels of AWGN be combined with the transmitted signal to approximate the interference created by users in other cells. To test the selectivity of the access terminal, tests are specified to simulate users operating at carrier frequencies adjacent to the channel of the Terminal under test. This is accomplished by summing single or dual CW signals with the Base Station transmit signal to act as adjacent channel interferers. A typical test model involving co-channel or adjacent channel interference is shown in Figure 1-2.

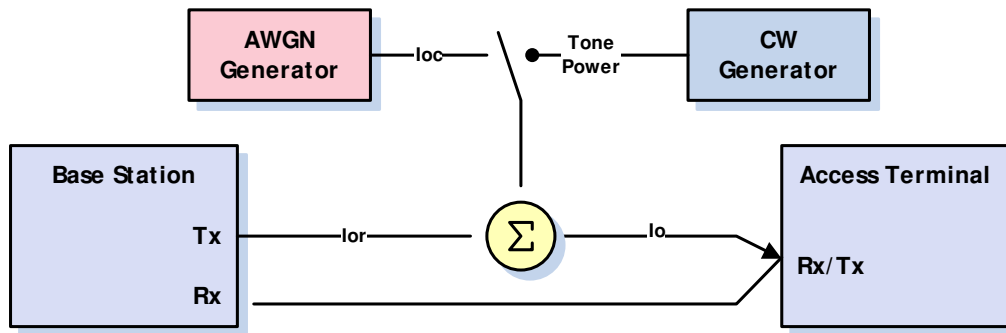


Figure 1-2: Access Terminal - Base Station Network Model for Demodulation of Forward Channel with co-Channel or Adjacent Channel Interference

1.2.2. EV-DO ATS Network Model

Meeting the specifications of the Access Terminal-Base Station Network Model discussed above requires sophisticated instruments capable of emulating the test environments in an accurate and repeatable manner. To be truly beneficial, these instruments must also be capable of emulating conditions beyond the minimum requirements defined by the industry test standards. By providing a broader range of test conditions, the system can find the performance limits of the access terminal under test.

EV-DO ATS allows for three main configurations of the Access Terminal-Base Station Link. This is made possible with the TAS5048 and SR5068, or SR8048 and optional SR8068 Test Configuration Units. . One or two auxiliary Base Station emulators may be added for EV-DO Rev B. Multicarrier Tests. The multiple basestation emulators are connected by a three-to-one combiner. The first configuration, shown in Figure 1-3, utilizes the SR5500 Wireless Channel Emulator in the forward path to provide impairments. In addition, a Base Station Emulator provides all the signaling and communication protocols necessary to initiate data connections as well as evaluate the Packet Error Rate (PER) performance of the access terminal

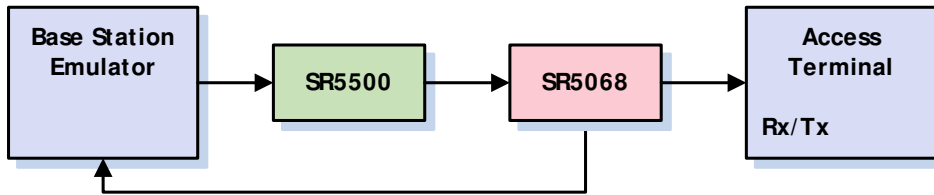


Figure 1-3: EV-DO ATS Test System

The second configuration, shown in Figure 1-4, provides a direct connection from the Base Station Emulator to the Access Terminal under test, shown below. The spectrum analyzer is available to measure Access Terminal transmit signals. This configuration is particularly useful for Access Terminal transmitter tests.

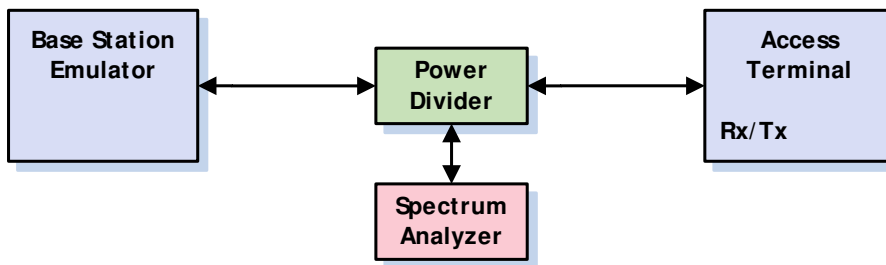


Figure 1-4: Direct Configuration of Base Station Emulator and Access Terminal Under Test

The third configuration, shown in Figure 1-5, utilizes the SR5500 to split the signal from the base station emulator into two independently impaired forward paths. These paths are connected to the primary and secondary receive antennae on the mobile station.

The reverse path is unimpaired and is transmitted solely on the primary antenna connection. This configuration is used for Receiver Diversity tests.

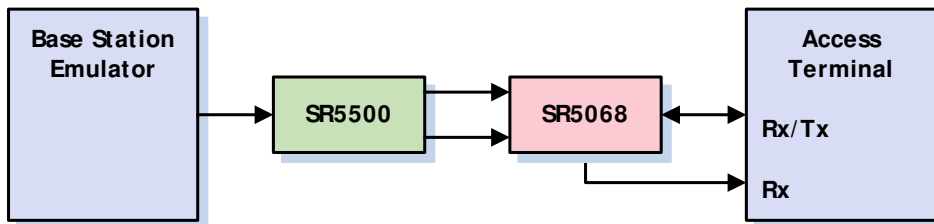


Figure 1-5: EV-DO ATS Receive Diversity Configuration

1.3. Version History

This version history highlights features and enhancements to EV-DO ATS since the first version of the product.

Version 5.10

- Added support for C.S0033 Revision C. This includes new modulated interferers for Test cases 3.3.2 and 3.3.3. All supported test cases have been updated to conform to this new standard revision. In addition, new standard suites pertaining to this revision of the specification have been created.
- Added support for 10 MHz and 5 Mhz LTE Interferers. This is required by some carrier acceptance test plans.
- Added support multi carrier test cases on the systems that include the SR8048 and SR8068 TCUs.
- Added support for a third Agilent 8960 when running multi carrier test cases. This allows you to execute three carrier test cases specified in the C.S033 standard.

The following maintenance updates have been added in the 5.10 release of TestDrive EV-DO:

- Corrected an issue with Trial passwords. Software features were not properly being enabled with Trial passwords.
- When running Idle Handoff in continuous operation mode or Forward Traffic Demod during soft handoff tests on system with SR8048 TCUs, you may encounter a level out of range error. This has been corrected.
- Corrected an error handling issue in Access Probe output power and Range of Open Loop power test cases.

Version 5.00

- Added Support for new TCUs; SR8048 and SR8068. This allows you to perform EV-DO and LTE testing on the same system without re-cabling the instruments used across test themes.

Version 4.70

- Added a reduced system configuration for automatically executing following test cases with the minimum ATS instrument (Agilent 8960 Base Station Emulator, Spectrum Analyzer, and SR5048).

3.1.2.4.1 Conducted Spurious Emissions.STE
3.3.1 Receiver Sensitivity and Dynamic Range.STE
4.1.2 Frequency Accuracy.STE
4.2.2 Waveform Quality and Frequency Accuracy.STE
4.3.1 Range of Open Loop Output Power.STE
4.3.3 Range of Closed Loop Power Control.STE
4.3.4 Maximum RF Output Power (Inside Japan).STE
4.3.5 Minimum Controlled Output Power.STE

- Modified following test cases to run using the physical layer Sub Type 3 (MCTAP) for the Rev. B tests as defined in **C.S0033-B v1.0** (dated May 12, 2008).

3.2.1 Demodulation of Forward Traffic Channel in AWGN
3.2.2 Single Tone Desensitization
3.3.1 Receiver Sensitivity and Dynamic Range.STE
3.3.2 Single Tone Desensitization
4.3.1 Range of Open Loop Output Power.STE
4.2.2 Waveform Quality and Frequency Accuracy.STE
4.3.4 Maximum RF Output Power (Inside Japan).STE
4.4.1 Conducted Spurious Emissions.STE

- Modified Instrumentation menu selection to run multi carrier EV-DO Rev B. tests.
- Modified database for the test case shown above to display the Rev. B test results.

Version 4.60

- Added C.S0033-A test 3.3.4 Adjacent Channel Selectivity. This is a Band Class 6 only test. It is similar to the existing Single Tone tests for other band classes but instead uses a modulated interference. **NOTE:** To run this test, ESG 1 must be equipped with Options 602 - Internal Baseband Generator.
- Reduced the path loss for the Receiver Sensitivity and Dynamic Range test (C.S0033-0 test 3.1.1.3.1 / C.S0033-A test 3.3.1) and the Minimum Controlled Output Power test (C.S0033-0 test 3.1.2.3.5 / C.S0033-A test 4.3.5). These tests are run at a high lor value and the levels' budgeting is very tight; it limits the acceptable loss between the Spirent system and the Mobile. These test cases have been modified to use a different path in the TCU which contains about 6 dB less loss. This allows some flexibility with regards to what cabling and devices you can put between the mobile antenna and the Spirent Equipment.
- Added a Delay before test parameter for all 3462 based tests. Due to an issue with some handsets, it is necessary to wait some period of time after a reset before starting a test. If this wait is not done the phone completes the reset after returning from the reset command and drops a call. The reset is done as part of session management with Air Access and the phone. 8960-based tests do not have this problem; as it is not necessary to reset the phone before each test.
- Added Support for new Agilent 8960 hardware version "5.8", as well as the corresponding E6706B lab application version. The older hardware/software (E6706A/E1966A) application versions will continue to be supported.
- Made a minor enhancement to the Password protection feature. In the *Suite* window, the Text Description and Override Channel text boxes could be selected but not edited. These controls were modified so that they cannot be selected like other controls when password-protection is enabled.
- Added a feature to send a test message when configuring the Email notification interface. This feature allows you to verify that the Email notification is set properly without having to run a test suite.

- Made some minor enhancements to the Diagnostic Debugging utility user interface. The enhancements clarified instructions and made it easier to navigate through debugging sequences.

The following maintenance updates have been added in the 4.50 release of TestDrive EV-DO:

- Corrected an issue that occurred when attempting to copy the intermediate results window. Clicking a “CTRL+C” combination was popping up error box saying “Error #438 (Object doesn’t support this property or method).”
- Corrected an issue where it was possible to pass the Standby Output Power test even if no probes were detected during the system access state. Since the test is attempting to measure the power between probes, if the phone fails to send access probes the test will be undetermined instead of a pass.
- Corrected an issue with Hard Handoff to Another Frequency test (C.S0033-0 test 6.1.1.2.4 / C.S0033-A test 6.6). When attempting to run this test for BC15 (AWS), BC6 (IMT2000) was getting set instead.
- Corrected an issue with several Soft Handoff test cases. The Traffic channel assignment message was not setting the proper value to specify soft vs softer handoff. Tests affected by this issue are:
 - 3.2.3 Decision of Power Control Bit for Channels belonging to Different Power Control Sets during Soft Handoff
 - 3.2.4 Decision of Power Control Bit for Channels belonging to the Same Power Control Set
 - 3.2.5 Demodulation of Reverse Power Control Channel during Soft Handoff.
 - 6.1 Idle Handoff in Continuous Operation Mode
 - 6.2 Idle Handoff in Slotted Operation Mode
 - 6.3 Neighbor Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.4 Candidate Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.5 Active Set Pilot Loss Detection in Soft Handoff
- Corrected an issue with Idle Handoff in Continuous Operation mode and Idle Handoff in Slotted Operation mode tests (C.S0033-0 tests 6.1.1.1.1, 6.1.1.1.2 / C.S0033-A tests 6.1, 6.2) Neighbor Count setting in Sector Parameter message was being incorrectly set to 0 causing the mobile to think there are no neighbors. This has been corrected.
- Corrected an issue with C.S0033-A test 5.3 Demodulation of Forward Traffic Channel during Soft Handoff. Test intermittently reported error retrieving FTAP parameters.
- It was observed that from time to time when an 8960 based test cases are running after an Air Access Test case the mobile appeared to be able to still see the Air Access Signal. This is likely an over the air leakage issue that would not occur if the mobile is in an isolation chamber. In order to avoid the possibility of this problem occurring, after all air access based tests are completed call processing is turned off in Air Access

- Active Set Pilot Loss Detection in Soft Handoff test (C.S0033-0 test 6.1.1.2.3 / C.S0033-A test 6.5) was sending the wrong PN value in the Traffic Channel Assignment message. This has been Corrected.
- There was an error in the State 2 Ior value reported in the intermediate results window of the Candidate Set Pilot Detection and Incorrect Detection in Soft Handoff test (C.S0033-0 test 6.1.1.2.2 / C.S0033-A test 6.4). The test was actually setting the right values but displaying the wrong value. This has been corrected.

Version 4.50

- TestDrive EV-DO no longer supports older TAS3460 AirAccess Instruments. The only supported Air Access hardware is now SR3452 V2s and SR3462.
- The following 3GPP2 C.S0033-0 and C.S0033-A tests have been modified to use the SR5500 to change levels during the course of test execution. This allows finer level resolution than the Air Access allowed in the previous implementation of these test cases. As a result the levels now conform exactly to the values listed in the testing standards.

C.S0033-0 Test #	C.S0033-A Test #	Title
3.1.1.2.5	3.2.5	Demodulation of Reverse Power Control Channel During Soft Handoff
6.1.1.1.1	6.1	Idle Handoff in Continuous Operation mode
6.1.1.1.2	6.2	Idle Handoff in Slotted Operation mode
6.1.1.2.1	6.3	Neighbor Set Pilot Detection and Incorrect Detection in Soft Handoff
6.1.1.2.2	6.4	Candidate Set Pilot Detection and Incorrect Detection in Soft Handoff
6.1.1.2.3	6.5	Active Set Pilot Loss Detection in Soft Handoff

- Added intermediate results for the Conducted Spurious Emissions test (C.S0033-0 test 3.1.2.4.1 / C.S0033-A test 3.4.1). Intermediate Results are now displayed for the Spurious Emissions test in the Test Results panel. This gives you more visibility into steps performed during test execution. It will also allow you to see how the device under test is performing while the test is executing, rather than having to wait until the suite is complete.
- Added Intermediate results for the Maximum RF Output Power test (C.S0033-0 test 3.1.2.3.4 / C.S0033-A test 4.3.4). Intermediate Results are now displayed for the max power test in the Test Results panel. This gives you more visibility into the test steps as it is being executed.
- The Session User Interface has been enhanced, allowing you to view terminal files and suite files directly from the session grid. Clicking the session grid still launches a file menu that points to a terminal file or suite file. The key sequence **CTRL+click** now displays the relevant suite file or terminal file.
- A diagnostics debugging tool has been added to the TestDrive EV-DO installation. This tool is installed to the “utilities” subfolder under the directory the TestDrive EV-DO application is installed in (the default location is **C:\Program Files\TestDrive\EV-DO\Utilities**). If the diagnostic procedure reports a failure, this tool leads you through a set of measurements to determine the cause of the diagnostic failure. Typically, when a diagnostic failure occurs, TestDrive EV-DO software instructs you to confirm that cables are connected properly and each unit is

powered-on correctly, but does not offer any additional assistance if everything is cabled properly and powered-on. The diagnostic debugging tool helps narrow down the exact cause of the failure in the event it is something more complex than a cabling error.

- TestDrive EV-DO has been modified to clearly indicate when there is a mismatch between the SR5500 instruments firmware and the API on the controller PC. Previous versions of TestDrive software would only indicate that there was an API error but not indicate the cause of the error. Error handling has been enhanced to clearly indicate when a Firmware mismatch occurs.
- Changed the default selection of parameters when characterizing mobile automation. The default set of automation features to characterize was none. This required you to select each of the parameters they want to characterize before running characterization. The typical usage of this feature is to characterize all available automation features unless attempting to access an unsupported feature causes a problem with the phone that would affect subsequent supported parameters. TestDrive EV-DO has been modified to have all parameters selected by default instead of none.
- Added the ability to set power step size for C.S0033A test 4.3.4 Maximum RF Output Power Test. This is a user settable parameter. Standard test suites still default to 1 dB but can be modified by users in order to test smaller step sizes.
- Enhanced results reporting for C.S0033A test 4.3.8.3 Data Channel Output Power. The Rev A version of this test has a variety of requirements that are validated as part of the test case. When this test fails the software was not providing sufficient data to easily determine the cause of the failure. This test has been modified to report a clear fail reason along with any test failures that occur.
- Increased the Maximum # of tests allowed in a suite. Previously the max number of rows was 255. The allowable number of rows has been doubled to 510.
- Added support for band class 10 for 8960 based test cases. Air Access does not support band class 10 so Test Pack 3 test cases cannot be run, but all test that use the 8960 Base Station Emulator can be executed for band class 10.
- Password protection of suits and sessions feature has been modified to no longer show a pop up window every time the TestDrive EV-DO software loads. Instead, you must go into software options to enable and disable this feature. When password protection is enabled TestDrive will launch in read only mode by default and anyone wishing to modify suites will have to disable read only mode by entering the correct password in the software options menu. In addition it was observed that in the rare event TestDrive software crashed or windows crashed after a new password was entered it was not being saved. The password protection feature has been modified to save the password as soon as it is entered rather than when the software is closed so that it is saved regardless how the software terminates.
- Modified the channel over ride feature available in the suite grid so it is less confusing. Previously the over ride channel only applied to tests executing in connected state and would be ignored for other test cases performed without a data connection established. For example idle handoff tests or access probe tests would ignore the over ride channel and instead execute on the channel number specified in the terminal file. Now when an over ride channel is specified it will be used

regardless of the test type. It is assumed that the channel is in the phones PRL for all non-connect state tests and all test cases that use the SR3462 EV-DO network emulator.

- Added e-mail notification feature for test execution events in TestDrive EV-DO. TestDrive software can be set up to send a notification email when suit execution starts, when it ends, if a fatal error occurs or if a specified number of undetermined test results occur.

The following maintenance updates have been added in the 4.40 release of TestDrive EV-DO:

- The displayed Eb/Nt was not correct for tests where FETAP was used. In some test cases, when FETAP was selected, FTAP parameters (data rate) were being used to calculate Eb/Nt. Parameters were being set up correctly in accordance to the test standards but value for Eb/Nt was being displayed incorrectly.
- For C.S0033A Test 5.5 Access Probes Output Power the sector ID used for the test did not match what was set in the terminal file. This has been corrected.
- For C.S0033A test 6.5 Active Set Pilot Loss Detection in Soft Handoff the wrong PN value that was being sent in the traffic assignment message. This has been corrected.
- For the "retry failed and undetermined test results" feature, the number of retries was not accurate when there was a mix of retests for undetermined and failed test results. This feature has been modified so that a single number of retries is settable. The TestDrive software will stop when the sum of failed and undetermined tests totals the set value.
- Corrected a possible loop gain issue. Under certain conditions it was possible to have loop gain in the RF signal path for some diversity test cases. This is not the case for all systems but could happen for systems with lower than average loss components and a higher than average amplifier in the TCU. The software has been modified to enable a TCU attenuator to avoid loop gain in paths it could have possibly occurred.
- Corrected a reverse loss setting error. This issue occurred for some diversity test cases only during data connection setup. The symptom of this issue is tests need several re-tries to setup a data connection when the setup channel number differs from the test channel number. In some instances the connection would not get setup and would result in undetermined test results. This issue has been corrected.
- Incorrect error reported when TestDrive was characterizing mobile automation. When characterizing NV item SCPStatus, and this item failed, TestDrive EV-DO reported an error message containing the wrong parameter name. This has been corrected.
- C.S0033A test 4.3.4 Maximum RF Output Power Test was using the downlink frequency for retrieving the uplink and downlink calibration values. Since the RF path for this test varies slightly over frequency the actual error in loss value was very minimal for most band classes. For Band Class 5 uplink and downlink frequencies are further apart resulting in a detectable error in test performance. This error been corrected.

- The last suite of a session was not getting saved properly. If a user loaded a session then swapped the last suite in that session and saved the session, the swapped suite was not getting saved. This has been corrected.
- Channel Output Power test (C.S0033-A test 4.3.7, 4.4.8.1, 4.4.8.2, and 4.4.8.3) have been enhanced to allow users to more easily and accurately characterize a mobile's channel output power requirements. The way averaging is set has been changed. There are two parameters associated with setting multiple measurements for this test. "Number of averages per measurement" indicates how many samples are used in calculating the average Code Channel power. The "number of measurements" parameter allows you to perform multiple measurements of the specified number of averages. When setting number of measurements to a value greater than 1 the test will report a fail if any of the specified number of measurements fails. In addition, the "RRI Gain" field has been changed to "RRIChannelGainPreTransition3" to clearly identify the parameter.
- C.S0033A test 4.3.8.3 Subtype 2 Test 5 was not setting the Aux gain to 3.5 dB as per the testing standard. This issue has been corrected.
- An issue was observed with multiple commercial handsets for Pilot Detect tests C.S0033A 6.3-6.5. The mobiles were dropping the call before the test was complete. It was determined that this was an issue resulting from the mobile being remotely reset and returning from the reset command before the mobile was completely reset. At some period after the reset command if a connection was active the mobile would drop the connection upon the actually completing the reset process. A "delay before test" parameter was added to the user interface. When testing a mobile whose device driver returns prematurely from a reset command, you should set the delay before test parameter to a value that ensures the mobile has completed a reset before the test starts.
- C.S0033A 4.3.2 Time Response of Open loop test was using the wrong data rate or sub type 2 test cases. This has been corrected.
- C.S0033A 6.4 Candidate Set Pilot Detection and Incorrect Detection in Soft Handoff, the location in the test sequence where the reset report is sent to the mobile has been changed. This is not defined in the testing standard but Qualcomm indicated that this message should be sent to the mobile immediately after state 1 levels are set in order to ensure the correct rout update message is analyzed.
- C.S0033A Test 6.1 Idle Handoff in Continuous Operation mode and Test 6.2 Idle Handoff in Slotted Operation mode intermittently were not terminating the data connection properly. Both tests are done in idle state but open a data connection to retrieve parameters. Intermittently an error could occur when ending the data connection causing the mobile to not return to idle state in order to continue the test. This has been corrected.
- C.S0033A test 4.3.4 Maximum output power for Band Class 5 the limits for Power Class 3 and 4 were interchanged in some of the Standard Test Suites. This has been corrected.
- C.S0033A test 3.2.3 Decision of Power Control Bit for Channel Different Set Sub Type 0 test suites appeared in the Sub Type 2 folder. The individual chapter suites for this test case were incorrect for sub type 2. This has been corrected. The "All Subtype 2

Tests (8960 based).STE” suite file did not contain this bug, only the individual chapter suite.

- For maximum output power tests and receiver sensitivity tests the spectrum analyzer is in the return path of the mobile’s transmit signal but the spectrum analyzer is not used to make any measurements as part of the test sequence. In these cases the spectrum analyzer is not set up to perform any measurements but is still receiving a very strong signal from the mobile and may be over driven. It was observed that over driving the spectrum analyzer could result in cross modulation products showing up in the receive band of the mobile and can effect test performance. Both test cases have been modified to set the spectrum analyzer’s input attenuator to stop overloads from occurring.

Version 4.40

- The following tests have been modified to run using physical layer Sub Type 2 (ETAP) in accordance with TIA-866-A/ C.S0033-A v1.0:
 - 3.1.1.2.5 Demodulation of Reverse Power Control Channel During Soft Handoff
 - 3.2.3 Decision of Power Control Bit for Channels Belonging to Different Power Control Sets During Soft Handoff
 - 3.2.4 Decision of Power Control Bit for Channels Belonging to the Same Power Control Set
 - 3.2.5 Demodulation of Reverse Power Control Channel During Soft Handoff
 - 5.2 Data Rate Control Performance
 - 5.3 Demodulation of Forward Traffic Channel during Soft Handoff
 - 5.4 Supervision Procedures in Variable Rate State
 - 5.6 Reverse Traffic Channel Initial Transmit Power
 - 6.1 Idle Handoff in Continuous Operation mode
 - 6.2 Idle Handoff in Slotted Operation mode
 - 6.3 Neighbor Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.4 Candidate Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.5 Active Set Pilot Loss Detection in Soft Handoff
 - 6.6 Hard Handoff to Another Frequency
- The following test has been modified to run using physical layer Sub Type 2 (ETAP) in accordance with the *Qualcomm Application Note: Recommended Minimum Performance for CDMA2000 1xEV-DO Revision A Rx Diversity-Capable Access Terminals, 80-VF496-11 Rev. A, May 17, 2007*. The Application Note details the EV-DO Rev. A Mobile Receive Diversity test cases:
 - 3.1.1.2.5 Demodulation of Reverse Power Control Channel During Soft Handoff
- Added support for Band Class 14 and Band Class 15.
- Added Support for Air Access version 3.10.

The following maintenance updates have been added in the 4.40 release of TestDrive EV-DO:

- IS 866A test 4.3.7 RRI Channel Output Power test was not setting RRI gain properly in the 8960 this value was changed to something other than what is specified in the testing standard. This has been corrected.
- There was an issue handling certain call processing errors for test where the Call Limit was set to on in the 8960. This has been corrected.

Version 4.30

The following enhancements have been added in the 4.30 release of TestDrive EV-DO:

- Added TIA-866A/C.S0033A test 3.2.6 Demodulation of ARQ Channel.
- Added the ability to remotely control TestDrive EV-DO over a socket connection or through an API on the same PC. This allows you to run suites across different ATS products. In addition, you can use a scripting language to control additional test instruments or power supplies, and run ATS tests as part of a larger test script.
- The following Test Drive EV-DO test cases have been modified to use averaging when taking the code channel measurements. This results in consistent and stable test results:
 - 4.3.7 RRI Channel Output Power
 - 4.3.8.1 DRC Channel Output Power
 - 4.3.8.2 ACK Channel Output Power
 - 4.3.8.3 Data Channel Output Power
 - 4.3.8.4 DSC Channel Output Power
- Added TIA-866A/C.S0033A test 3.2.6 Demodulation of ARQ Channel.

- Added a rate of change measurement to C.S0033-A test 4.2.1 Time Reference. Previously, Test Drive EV-DO measured only the static case. The SR5500 is used to introduce a delay of the forward path. The mobile's ability to synchronize to that delay within the timing constraints in the testing standard is now measured.
- Added the ability to perform margin testing for packet error rate tests. TestDrive EV-DO now supports margin testing for Receiver Sensitivity, Single Tone Desensitization and Intermodulation Spurious Response. Margin testing characterizes the mobile's ability to perform beyond the limit specified in the standards. The impairment used in a given test is increased to determine how far beyond the level specified in the standard the mobile can still operate at or below the specified maximum packet error rate.
- Enhanced results reports ensure clearly define what each test case is testing. For some test cases, it was difficult to determine by viewing the results report what standard the phone is being held to. This is common for tests that do not include user-defined pass/fail limits. TestDrive EV-DO reports were enhanced to ensure that all tests clearly define what pass/fail criteria used, as well as the failure reason for failed tests.
- Added limit lines to the results report for Time Response of Open Loop Power Control tests (C.S0033 test 3.1.2.3.2 or C.S0033A test 4.3.2).
- Enhancement communication logging feature to enable more efficient debugging of issues. The Communications Log now includes Test Description and Status. Any errors that occur during test execution are now logged.
- Enhanced code that interfaces to the UTS driver to make Test Drive EV-DO compatible with the latest generic driver.
- Added a feature to allow password protection of suite and session parameters. If this feature is enabled, only entering the password will allow editing suite and session settings.

The following maintenance updates have been added in the 4.30 release of TestDrive EV-DO:

- Corrected an issue with the fading profile for some of the subtests in C.S0033-A test 3.22 Demodulation of Forward Traffic Channel in Multi-path Fading Channel.
- Corrected an issue with C.S0033-A test 4.4.1. The absolute emissions sweep was wrong for close in spurs. Because the test specifies the "least stringent" of the absolute and relative sweeps, most mobiles pass this test by passing the relative sweeps. Observing the graphs showed an issue with the absolute sweeps. This has been corrected.
- C.S0033-A test 5.4 Supervision Procedures in variable rate state could get caught in an endless loop, and not complete the test. When triggering rate transitions, this test would loop waiting for a transition. If the transition never occurred, it would not exit the loop. This issue has been corrected.

- C.S0033-A test 4.3.3 Range of Closed loop power test had an issue capturing the slope measurements for mobiles with have a significant delay between when the all down power control bits are sent and when the mobile starts changing its output power. This test has been modified to dynamically alter the delay before the spectrum analyzer sweep begins.
- For some mobiles, there was an issue triggering the second sweep for C.S0033-A Test 5.5 Access Probe Output Power test. The video trigger value was set to low and causing the spectrum analyzer trace to trigger too early. This has been corrected.
- Corrected an issue with C.S0033-A test 3.2.3 Decision of Power Control Bits (Different set) During Soft Handoff and test 3.2.4 Decision of Power Control Bits (Same Set) During Soft Handoff.
AirAccess was lowering the mobile power level before starting the power control bit pattern prescribed by the test specification. This could cause the lower part of the mobile transmit power traces to occur in the noise floor of the spectrum analyzer, or hit the lower power limit of the mobile. This test has been modified so the average power (before the test's power control bit pattern starts) is high enough to prevent this issue.

Version 4.20

The following enhancements have been added in the 4.20 release of TestDrive EV-DO:

- The following EV-DO Rev. A Mobile Receive Diversity test cases have been implemented. These tests are specified by the Qualcomm Application Note, detailing the EV-DO Rev. A Mobile Receive Diversity test cases:
 - 3.2.1 Demodulation of Forward Traffic Channel in AWGN
 - 3.2.2 Demodulation of Forward Traffic Channel in Multi-path Fading Channel
 - 3.3.1 Receiver Sensitivity and Dynamic Range
 - 3.3.2 Single Tone Desensitization
 - 3.3.3 Intermodulation Spurious Response Attenuation
- The following EV-DO Rev. 0 test cases were not meeting the levels requirement specified in the test specification (TIA-866). The test cases have been enhanced to achieve the specified test levels by using amplifiers in the 5068:
 - 3.1.1.2.5 Demodulation of Reverse Power Control Channel During Soft Handoff
 - 6.1.1.1.1 Idle Handoff in Continuous Operation mode
 - 6.1.1.1.2 Idle Handoff in Slotted Operation mode
 - 6.1.1.2.1 Neighbor Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.1.1.2.3 Active Set Pilot Loss Detection in Soft Handoff
- Added a feature to allow the running of Single Tone Desensitization, Receiver Sensitivity with all up power control bits.
- Added the ability to export results to PDF format. **NOTE:** This feature requires software package called *PDF995* be installed on the PC.

- TestDrive EV-DO have been enhanced to provide an option automatically re-run tests that result in “Undetermined” and/or “Fail” status. The re-run will occur immediately following the failed or undetermined test status. You have the ability to select, “Undetermined”, “Fail” or both be re-executed. The maximum number of times the software will automatically retry a test is user-configurable. Note that the specified number is the sum of both fail and undetermined test.
- Modified some diagnostics error messages to better direct the customer to the cause of the errors.
- Added the ability to specify a Minimum Frame count for Packet Error Rate tests when confidence testing is turned on in the 8960. This feature is important when running fading tests to ensure the mobile is exposed to the full time varying fading profile before truncating the test due to the confidence requirement being met.
- Added support for Band Class 15 (AWS Band) for 8960 based test cases. TestDrive EV-DO now enables you to test Band Class 15 access terminals for all tests except those that use the SR3462.
- Improved the timing accuracy of level variations for C.S0033A test 6.1 Idle Handoff in Continuous Operation Mode and 5.3 Demodulation of Forward Traffic Channel during Soft Handoff. The TestDrive EV-DO software was modified to make use of the DEE feature in the SR5500 which provides highly accurate level cycling for the tests.
- Added ability to track suite and session duration. TestDrive EV-DO already allowed you to view how long individual tests took to execute. Now it is possible to view execution duration totals for both suites and Sessions.

The following maintenance updates have been added in the 4.20 release of TestDrive EV-DO:

- Corrected issues with test duration fields. Several TestDrive EV-DO test cases had missing or inaccurate test duration results. These have been fixed.
- Candidate detect tests (C.S0033A tests 6.3-6.5) have been modified to more accurately conform to the testing standard. Spirent received some clarifications from Qualcomm regarding these test cases and has incorporated those into the TestDrive EV-DO software. The changes primarily involve ensuring the pilots are in the proper sets before disabling responses to rout update messages.
- An issue was corrected where after a session is executed with all instruments being marked as available in system, followed by a session in which only the Base Station is marked as being present, suites were unable to run properly reporting “object with block is not set”.
- Corrected an issue when launching the help feature from the diagnostic window.
- Corrected an error that occurred when attempting to generate a details report for test 3.1.2.4.1 Conducted Spurious Emissions, when sorting on failed tests results only.
- In a recent TestDrive EV-DO release the ESN database field was replaced by the Hardware ID field. In some cases the Hardware ID was not getting written properly for some mobiles. This issue has been corrected.
- Corrected the throughput calculations for several test that use variable data rate. Calculations were incorrect because they were not taking into consideration the fact

that packet size may vary. Observed errors in calculations resulted in a lower than expected throughput result.

Version 4.00

The following enhancements have been added in the 4.00 release of TestDrive EV-DO:

- The following new TIA-866-0 test cases are now supported in TestDrive EV-DO.
 - 3.1.1.2.3-Decision of Power Control Bit for Channels Belonging to Different Power Control Sets During Soft Handoff
 - 3.1.1.2.4-Decision of Power Control Bit for Channels Belonging to the Same Power Control Set
 - 3.1.1.2.5-Demodulation of Reverse Power Control Channel During Soft Handoff
 - 4.2.1.1 -Data Rate Control Performance
 - 4.2.1.2 -Demodulation of Forward Traffic Channel during Soft Handoff
 - 4.2.1.3 -Supervision Procedures in Variable Rate State
 - 4.3.1.1 -Access Probes Output Power
 - 4.4.1.1-Reverse Traffic Channel Initial Transmit Power
 - 4.4.1.4 -Reverse Traffic Channel MAC Rate Transition Probabilities
 - 6.1.1.1.1 -Idle Handoff in Continuous Operation mode
 - 6.1.1.1.2 -Idle Handoff in Slotted Operation mode
 - 6.1.1.2.1 -Neighbor Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.1.1.2.2 -Candidate Set Pilot Detection and Incorrect Detection in Soft Handoff
 - 6.1.1.2.3 -Active Set Pilot Loss Detection in Soft Handoff
 - 6.1.1.2.4 -Hard Handoff to Another Frequency
- The following 80-V8941-1 Rev. C test is now supported in TestDrive EV-DO
 - 3.7 FTC MAC Protocol: Data Rate Control Performance
 - Added Support for the following 8960 Application versions:
 - E1966A EV-DO Test Application Version: A.06.10
 - E1966A EV-DO Lab Application Version: A.03.10
- The following tests have been enhanced to conform to C.S0033 Rev A. Most of the enhancements pertain to support for testing Subtype 2 Physical Layer and additional channels such as DSC. The following is a comprehensive list of tests :
 - 3.1 -Frequency Coverage Requirements
 - 3.2.1 -Demodulation of Forward Traffic Channel in AWGN
 - 3.2.2 -Demodulation of Forward Traffic Channel in Multi-path Fading Channel
 - 3.3.1 -Receiver Sensitivity and Dynamic Range
 - 3.3.2 -Single Tone Desensitization
 - 3.3.3 -Intermodulation Spurious Response Attenuation
 - 4.1 -Frequency Coverage Requirements

- 4.1.2 -Frequency Accuracy
- 4.2.1 -Time Reference
- 4.2.2 -Waveform Quality and Frequency Accuracy
- 4.3.2 -Time Response of Open Loop Power Control
- 4.3.4 -Maximum RF Output Power
- 4.3.5 -Minimum Controlled Output Power
- 4.3.8.1 -DRC Channel Output Power
- 4.3.8.2 -ACK Channel Output Power
- 4.3.8.4 -DSC Channel output power
- 4.3.7 -RRI Channel Output Power
- 4.3.8.3 -Data Channel Output Power
- 4.3.3 -Range of Closed Loop Power Control
- 4.4.1 -Conducted Spurious Emissions

The following maintenance updates have been added in the 4.00 release of TestDrive EV-DO:

- Test 3.1.2.3.3 Range of Closed Loop Power Control failed intermittently due to a timing issue measuring the absolute power level. This issue was fixed.

Version 3.10

The following enhancements have been added in the 3.10 release of TestDrive EV-DO:

- Added Support for the following 8960 Application versions:
 - **E1966A EV-DO Test Application Version: A.05.11**
 - **E1966A EV-DO Lab Application Version: A.02.21**
- MEID reporting: TestDrive EV-DO has been enhanced to query and report a Hardware ID value. This value will be an MEID if reported from a MEID-equipped AT or an ESN if reported from a ESN-equipped AT. All places that used to display ESN have been modified to display the new value under the heading of “Hardware ID.” The database viewer has also been enhanced to sort results by “Hardware ID”.
- TIA-866 Test 3.1.2.3.7: The RRI Channel Output Power test has been enhanced per Qualcomm recommended values as follows: *AT Directed packets = 0%, ACK channel bit fixed mode attribute = OFF, Number of slots to measure = 8.*

The following maintenance updates have been added in the 3.10 release of TestDrive EV-DO:

- Database Viewer: The following issues were resolved for the Database Viewer:
 - For reports generated in custom field’s mode, an exception was thrown when the following fields were added: Tone Enabled, Tone Offset, and Tone Level.
 - An error was thrown when the report was restricted by ESN. However, ALL as a selection for ESN would work.

- When the **Results.ResTestDuration** or **Results.ResTestErrors** fields were selected for the custom report, an error message was generated indicating that there were too few parameters.
- The mdb file window needs to be labeled with the correct product title of “TestDrive/EV-DO” instead of “TASKIT/C2K.”
- Calibration: The following issues were resolved with respect to calibration:
 - Step BACIL has been corrected to calibrate that path correctly.
 - An exception was thrown while using EV-DO Lab Application for calibration.
- Instrument Configuration: Removed **TAS 4600** as a supported element from the menu.
- Communication log: Issues corrected that prevented this logging to work properly when running sessions using terminal files from older releases. In addition, fixed an issue with retaining the setting across re-starts of the test application.
- Intermittent crashes: Fixed an issue causing the test application to crash when executing long sessions.
- TIA-866 Test 3.1.1.2.1: Demodulation of Forward Traffic Channel in AWGN Test 7 had an invalid data rate. It has been corrected to 1,228.8 kbps with Slots per Physical Layer packet=2.
- TIA-866 Tests 3.1.1.2.1, 3.1.1.2.2 and 3.1.1.3.1: Max PER values for these suits have been modified to make them consistent with the standards.
- TIA-866 Test 3.1.1.3.3: Sub-tests 11 and 12 were mislabeled to be the same as sub-tests 5 and 6. The parameters were correct per the standard.

Version 3.00

The following system changes have been added in the 3.00 release of TestDrive EV-DO:

- The 3.00 release supports a new System Architecture for running Receiver Diversity tests. New systems delivered going forward will no longer include the SR5058. The SR5058 has been replaced by the new SR5068 Test Configuration Unit. The SR5068 works in conjunction with the TAS5048 to provide automated switching of RF signal paths for the various test cases supported by the TASKIT/C2K software.

The following TIA/EIA-866-1 based Rx Diversity tests have been added in the 3.00 release of TestDrive EV-DO:

- 3.2 Receiver sensitivity and dynamic range
- 3.3 Single tone desensitization
- 3.4 Intermodulation spurious response
- 3.5 Forward traffic channel demodulation in AWGN
- 3.6 FTC demodulation in multi-path fading channel

Version 2.20

The following enhancements have been added in the 2.20 release of TestDrive EV-DO:

- Added Support for the following 8960 Application versions:
 - E6706A EV-DO Lab Application Version: A.01.12

- E1966A EV-DO Test Application Version: A.03.17
- Added Support for SR5500 version 1.31.
- In conjunction with the AirAccess C2K 2.60 release, TestDrive EV-DO now supports the ability to track how long the application has been running, how long sessions have been executing and how long suites have been executing. This data is logged and viewed with the Spirent Applications Monitor (delivered with AirAccess C2K 2.60).
- TestDrive EV-DO now provides the capability for remote control. The interface to control TestDrive EV-DO is documented in the updated User Manual delivered with the TestDrive EV-DO 2.20 installation, as well as in Section 7 of this Product Update.

The following maintenance updates have been added in the 2.20 release of TestDrive EV-DO:

- The following test cases were missing the test channel number result in the database viewer results and reports:
 - 3.1.2.1.2 Frequency Accuracy
 - 3.1.2.2.1 Time Reference
 - 3.1.2.2.2 Waveform Quality and Frequency Accuracy
 - 3.1.2.3.2 Time Response of Open Loop Power Control
 - 3.1.2.3.6 Standby Output Power
 - 3.1.2.3.7 RRI Channel Output Power
 - 3.1.2.3.8.1 DRC Channel Output Power
 - 3.1.2.3.8.2 ACK Channel Output Power
 - 3.1.2.3.8.3 Data Channel Output Power
 - 3.1.1.4.1 Conducted Spurious Emissions
- Transmitter Spurious test: The Database Viewer report restrictions did not work properly. Attempting to view only “failed tests” yielded a “20515 Error in formula” message.
- Range of Open Loop test: This test was been repeated for multiple test channels. This has been changed because this is not a traffic channel test.
- TIA-866 Test 3.1.2.3.3 Range of Closed Loop: This test was setting the wrong Spectrum Analyzer Offset.
- Range of Closed Loop test: A Noise Correction algorithm was implemented. TestDrive EV-DO now sweeps the noise floor of the spectrum analyzer and subtracts it from the range of closed loop trace data. This results in a more accurate measurement of the transmitted mobile power.
- Some standard suite descriptions contained “RC” in the description. These have been removed.

Version 2.10

The following system changes have been added in the 2.10 release of TestDrive EV-DO:

- The 2.10 release supports a new System Architecture. New systems delivered going forward will no longer include a TAS5600. The impairment capabilities of the TAS5600 have been replaced by two Agilent ESG Tone Generators and the AWGN option in the SR5500. This new system also includes an SR5058 Test Configuration Unit. The SR5058 works in conjunction with the TAS5048 to provide automated switching of RF signal paths for the various test cases supported by the TestDrive EV-DO software.

Version 2.00

The following C.S0033 AT-MPS tests are supported in the 2.00 release of TestDrive EV-DO:

- 3.1.1.4.1 Receiver Conducted Spurious Emissions
- 3.1.2.1.2 Frequency Accuracy
- 3.1.2.2.1 Time Reference
- 3.1.2.2.2 Waveform Quality and Frequency Accuracy
- 3.1.2.3.1 Range of Open Loop Output Power
- 3.1.2.3.2 Time Response of Open Loop Power Control
- 3.1.2.3.3 Range of Closed Loop Power Control
- 3.1.2.3.4 Maximum RF Output Power
- 3.1.2.3.5 Minimum Controlled Output Power
- 3.1.2.3.6 Standby Output Power and Gated Output Power
- 3.1.2.3.7 RRI Channel Output Power
- 3.1.2.3.8.1 DRC Channel Output Power
- 3.1.2.3.8.2 ACK Channel Output Power
- 3.1.2.3.8.3 Data Channel Output Power
- 3.1.2.4.1 Transmitter Conducted Spurious Emissions

The following new features have been added for this release:

- Support for Windows XP
- Support For Band Class 6 Access Terminals.

The following errors have been corrected:

- Mismatch between cabling diagram and text instruction for calibration step 6 of calibration routine. The diagram has been corrected
- Error in the displayed Eb/Nt for Packet Error Rate test. The result for Packet Error Rate tests includes a calculated Eb/Nt value. The code making this calculation was flawed and has now been corrected.

- Intermittent Communication issue with Agilent Base Station Emulator. The symptom of this issue was the display of the following error: “Error #:-107380733 Description: Timeout expired before operation completed.” There were cases where the TestDrive EV-DO software would attempt to setup a data connection when a session with the access terminal had not been opened. Doing this would intermittently force the 8960 to become unresponsive to remote commands. TestDrive has been modified to ensure a session is open before any Data Connections are attempted.
- IS866 3.1.1.3.1 Receiver Sensitivity and Dynamic Range (Test 2). The standard suite had an incorrect FTAP data rate of 307.2 kbps 2 slot. The suite has been changed to the correct value of 2457.6 kbps 1 slot.

Version 1.00 (Initial Version)

The following C.S0033 AT-MPS tests are supported in the 1.00 release of TestDrive EV-DO:

- 3.1.1.1 Frequency Coverage Requirements
- 3.1.1.2.1 Demodulation of Forward Traffic Channel in AWGN
- 3.1.1.2.2 Demodulation of Forward Traffic Channel in Multi-path Fading Channel
- 3.1.1.3.1 Receiver Sensitivity and Dynamic Range
- 3.1.1.3.2 Single Tone Desensitization
- 3.1.1.3.3 Intermodulation Spurious Response Attenuation
- 3.1.2.1.1 Frequency Coverage Requirements

2. System Overview

2.1. Overview

The EV-DO Automatic Test System (EV-DO ATS) provides an integrated test solution for evaluating EV-DO Access Terminals. By combining the SR5500 Wireless Channel Emulator, CW Interference Emulator with a base station emulator and essential CDMA Test equipment, a turn-key test system is produced. TestDrive EV-DO Windows software automates access terminal testing by configuring the instruments, stepping through the test sequences, and logging the results.

2.2. Guided Tour

EV-DO ATS combines powerful instruments and software into a comprehensible integrated test system. The major components of this system include:

- TestDrive EV-DO Automatic Test Executive
- SR5500 Wireless Channel Emulator with AWGN option
- TAS5048 and SR5068 Test Configuration Units
- Base Station Emulator (s) (one to three Agilent 8960)
- SR3452 V2 CDMA Network Emulator (two)
- SR3462 EV-DO Network Emulator
- Spectrum Analyzer (Agilent E44xxB ESA Series)
- CW Generators (Agilent E4438B) (two)
- RF Control System (Agilent 3499A)

2.2.1. *TestDrive EV-DO Automatic Test Executive*

TestDrive EV-DO is a Windows-based software test executive that implements tests specified in the 3GPP2 C.S0033 (TIA-866) AT-MPS test standard. By providing access to key test parameters, the software permits evaluation beyond minimum performance standards by allowing custom test scenarios to be created.

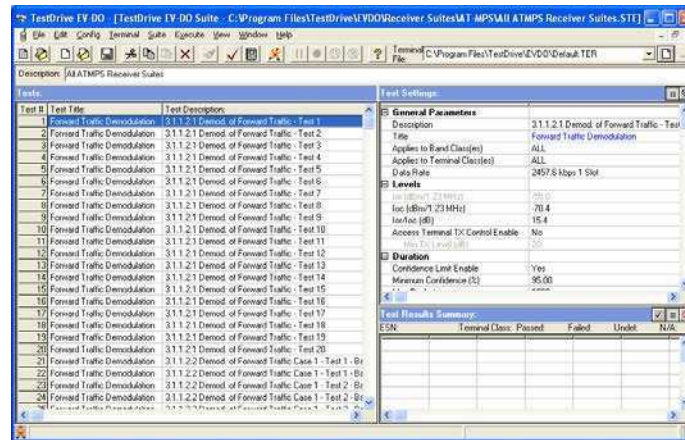


Figure 2-1: TestDrive EV-DO Test Executive Window

TestDrive EV-DO is comprised of a powerful test executive, pre-defined test suites, instrument drivers, and custom development tools. The test software runs on any PC equipped with a National Instruments GPIB card and Microsoft Windows 2000 or Windows XP operating systems. TestDrive uses the GPIB card port and Ethernet port to communicate with the instruments in the system.

TestDrive EV-DO simplifies test setup and conserves valuable resources by performing the following:

- Mapping test parameters to instrument settings.
- Configuring instruments.
- Establishing data connections between the device under test and the base station emulator.
- Managing test information.
- Executing comprehensive automatic tests.
- Logging and reporting test results.

2.2.2. Spirent SR5500 Wireless Channel Emulation

The SR5500 RF Channel Emulator, shown in Figure 2-2, provides the ability to assess an Access Terminal's capacity to mitigate multi-path effects by emulating the delay, fast and slow fading, and path loss characteristics of RF Terminal communication channels.



Figure 2-2: SR5500 Wireless Channel Emulator

A single SR5500 provides a superset of the requirements for EV-DO testing. The SR5500 emulates two independent wide bandwidth RF channels, each with up to twelve transmission paths. Delay, path loss, Rayleigh fading, and log-normal fading characteristics can be programmed for each path. When the AWGN option is enabled, Additive White Gaussian Noise can be added to both channels as well. Refer to the **SR5500 Wireless Channel Emulator User Manual** for further details about the features and operation of the instrument.

2.2.3. Spirent TAS5048 and SR5068 Test Configuration Units

The TAS5048 Test Configuration Unit automatically manages the switching of RF connections required for EV-DO device testing. This allows EV-DO ATS to achieve the highest level of flexibility in test coverage.



Figure 2-3: TAS5048 Test Configuration Unit

Combined with the Agilent 3499B Logic/Control System, the TAS5048 is automatically controlled with TestDrive EV-DO software. Reconfiguring the EV-DO signaling path in EV-DO ATS is automatically handled by TestDrive EV-DO.

EV-DO ATS supports the Agilent 8960 Base Station Emulator with the following configuration:

- E5515C Test Set Mainframe
- E1966A 1xEV-DO test application
- Option AX5 Rack flange kit with handles

2.2.6. *Spectrum Analyzer*

The Spectrum Analyzer is used to perform system calibration, system diagnostics, and transmitter measurements of the mobile station.

In EV-DO-ATS, the system routes the mobile transmitter to the spectrum analyzer. The spectrum analyzer is then used to perform EV-DO transmitter tests as specified in TIA and 3GPP2 testing standards.

EV-DO-ATS supports the three spectrum analyzers shown below. They are listed along with the required instrument options.

E44xxB ESA Series:

- Option A4H – GPIB and Centronics Interfaces.
- Option 120 – ACPR dynamic range extension.
- Option 1CP – Rack mount and handle kit.

E44xxB EXA Series:

- Model must be N9010A-5xx, where xx=03, 07, 12, or 26
 - Option 120:
Optional: 1CP (Rack mount kit with handles)

E44xxB EXA Series:

- Model must be N9020A-5xx, where xx=03, 07, 12, or 26
 - Option 120
Optional: 1CP (Rack mount kit with handles)

Refer to the Agilent Spectrum Analyzer User Manuals for details about the features and operation of these instruments.

2.2.7. Vector Signal Generator (Two Units Required)

The Vector Signal Generator provides dual tone and adjacent channel modulated interference emulation required to evaluate receiver performance

For interference generation purposes, EV-DO-ATS supports the Agilent E4438C ESG Vector Signal Generator.

The following options are required in the Agilent Signal Generator:

- Option 503 250 kHz to 3.0 GHz Frequency range.
- Option 1E5 –High Stability Time Base.
- Option UNJ - Enhanced Phase Noise Performance.
- Options 602 - Internal Baseband Generator. Required for the coverage of Band Class 6 specific Adjacent Channel Selectivity (3GPP2 C.S0033-0 Test 3.1.1.3.4/C.S0033-A Test 3.3.4).*

*This test coverage requires uploading Modulated Interference Waveforms on one ESG with Option 602. To upload the waveforms, set up a LAN connection and open a FTP connection from the Controller PC to the ESG. Refer to the ESG E4438C Manual for FTP setup. After establishing the connection, copy the waveforms from the folder " C:\Program Files\TestDrive\EVDO\Utilities\ESG Waveforms" to the "SECUREWAVE" folder on the ESG.

2.2.8. Air Access Protocol Test System

AirAccess provides both CDMA2000 1X (including IS-95A/B and J-STD-008) and 1xEV-DO network emulation. For purposes of the EV-DO Automated Test System, only the EV-DO network emulation capabilities of this product are used. The main components of this product are as follows:

- *AirAccess Software*: The AirAccess software is a Windows-based application that provides the ability to configure and control a wide range of emulated wireless network infrastructure components from within an easy-to-use GUI. This software also provides an API interface which enables TestDrive EV-DO to configure the EV-DO network emulation parameters required to execute the various tests.
- *Dual SR3452V2 CDMA Network Emulators*: In EV-DO mode, these instruments provide the RF components for the SR3462 EV-DO network emulator. They also provide CDMA 2000 network emulator capabilities used in other product areas such as the C2K-ATS.
- *SR3462*: This unit provides emulation of multiple 1xEV sectors. The SR3462 interfaces with access terminal under test via the RF converters embedded inside the two SR3452 V2 CDMA Network Emulators.

2.2.8.1 Powering the SR3462 Systems

Repeat the following sequence when the controller PC, router, or Air Access hardware is turned off. Follow these steps in cases where AirAccess or TestDrive EV-DO indicates errors communicating with the TAS3460 unit or SR3462. In this case, power off the TAS3460 or SR3462 unit before following the instructions below.

1. Power on the Router, followed by the Controller PC.
Log onto the controller PC.
2. Power on the primary SR3452, followed by the secondary SR3452.
3. After the SR3452 units are running with a solid LED, power on the SR3462.
4. When the LED is solid green, the SR3462 has booted up successfully and is ready to use.

2.3. Installing EV-DO ATS Software

This section provides the details for installing the software in the EV-DO ATS. The software included in the EV-DO ATS is TestDrive EV-DO. In addition to the TestDrive EV-DO it is necessary to install TestKit 5500 so that the proper SR5500 Instrument API is available for use by the TestDrive EV-DO application.

2.3.1. TestKit 5500

NOTE: When installing TestDrive EV-DO for the first time, it is necessary to install TestKit 5500 so that the SR5500 Instrument API is installed on the PC for use by TestDrive EV-DO. Unless the firmware of the SR5500 is updated, it is not necessary to reinstall TestKit 5500 as part of TestDrive EV-DO upgrades.

TestDrive EV-DO is distributed on CD only.

To install the TestDrive EV-DO Test Executive and Test Suites on your computer:

1. Place the **RF Testing Applications** installation CD still in the CD drive.
2. Run SETUP.EXE from the **SR5500TestKit** directory on the CD.
3. Click **OK** to continue with the setup.
4. A window displays a **Please wait** message.
5. The *Welcome to the SR5500 TestKit Setup Wizard* window displays. Click **Next**.
6. In the **Select Installation Folder** window:
 - a. Select **Everyone**.
 - b. Click the **Next** button.
7. In the *Confirm Installation* window, click the **Next** button.
8. When the *Installation Complete* window displays, click the **Close** button.
9. Click **OK** in the *Application Setup* window.

2.3.2. TestDrive EV-DO Test Executive

NOTE: When installing TestDrive EV-DO under Windows 2000 or Windows XP, it is necessary to log onto the machine with administrative privileges.

TestDrive EV-DO is distributed on CD only.

To install the TestDrive EV-DO Test Executive and Test Suites on your computer:

1. Confirm that Windows 2000 or Windows XP is the current operating system on your computer. Also verify that National Instruments VISA Drivers Version 2.0 or later are installed on your computer.
2. If you currently have a previous version of TestDrive EV-DO, uninstall it prior to installing this new version. Select **Control Panel>Add/Remove Programs** to uninstall any previous versions.
3. Place the TestDrive EV-DO CD in the PC CD drive. The install program should start automatically. If not, select **Start Menu>Run**, enter **D:\SETUP** in the text box and click **OK** (If your CD Drive is not D, substitute the appropriate drive letter).
4. TestDrive EV-DO Setup configures Windows Installer on your computer. It may be necessary for setup to restart your computer for the configuration to take place. If you are prompted to restart the computer, click **Restart**. Setup will automatically continue after the computer reboots. If it does not start automatically, run the installation again, as described in the previous steps.
5. The *Welcome* window displays signifying the start of the installation process. Click the **Next** button to continue.
6. The Spirent Software License Agreement displays. Read through it and then select **I accept the terms in the license agreement** and click the **Next** button.
7. On the next screen, enter your User Information, including your **User Name** and **Organization**. Fill out all applicable information and click the **Next** button.
8. Select the destination folder where you want the TestDrive EV-DO software installed. We recommend you use the default installation subdirectory. Click **Next** to continue.
9. In the *Setup Type* window, select **Complete Installation** and click the **Next** button.
10. At this point, TestDrive EV-DO Setup is ready to begin installing the software onto your computer. Click **Install** to begin this process.
11. Once the installation process is complete, you may be asked to restart the computer in order for the changes to take effect. Click **Yes** to restart the computer.
12. You may now begin using the TestDrive EV-DO Test Executive software and Test Suites.

2.3.3. EV-DO ATS User and Reference Manuals

This User Manual and the Reference Manual are available on the CD. Use Windows Explorer to view the D:\Manuals folder (replace “D:” with the appropriate letter if your CD drive is not D). This folder contains a file called TestDrive EV-DO USER MANUAL.PDF, which is this manual. The folder also contains a file called TestDrive EV-DO TEST REFERENCE MANUAL.PDF, which contains test, parameter, and results descriptions. These manuals are also installed with TestDrive EV-DO in a Manuals subfolder in the program directory. You can view and print these files using Adobe Acrobat Reader. If not already installed on the PC, a self-extracting installation of Adobe Acrobat Reader can be found in the Adobe Acrobat Setup directory in the TestDrive folder.

2.3.4. Copy Protection

To protect the software from being used illegally, TestDrive EV-DO looks for a hardware key. Each product has its own hardware key. One hardware key is shipped with every copy of the product. The hardware key connects to your PC’s parallel port. To connect the hardware key(s), attach the key to your the parallel port in your PC.

If you have a device already connected to your PC’s parallel port, follow these steps to install your hardware key:

1. Disconnect the parallel device.
2. Connect the hardware key(s) to your PC’s parallel port.
3. Reconnect the parallel device to the hardware key.
4. Repeat steps 1-3 to connect multiple keys to the same parallel port.

If a hardware key is not detected, certain software features are unavailable. In TestDrive EV-DO, a window displays indicating the problem when test execution is selected. Test execution continues, but the instruments cannot be controlled. Instead, test execution operates in a demonstration mode. In **Demonstration Mode**, the software appears to be performing a test and collecting results. All test results are simulated by the software.

NOTE: TestDrive EV-DO also requires a password to be entered into the application. Refer to Section 4.10, Security Features for more information.

2.4. Rack Assembly

For detailed instructions on how to build and connect your EV-DO ATS System, refer to the Setup Guide(s) included with your system.

3. TestDrive EV-DO

3.1. Overview

This chapter provides an introduction to the basic steps that are typically required to successfully operate TestDrive EV-DO. This includes the following steps:

- Starting TestDrive EV-DO
- Setting the Communications Options for the PC
- Configuring the Terminal Settings
- Performing a Diagnostic and Calibrating the system.
- Loading a Pre-defined Test Suite
- Running a Test Suite
- Viewing Test Results

3.2. Starting TestDrive EV-DO

To start TestDrive EV-DO:

Select Windows **Start Menu>Programs>Spirent Communications>TestDrive EV-DO>TestDrive EV-DO**.

The table below lists the program icons that display.

Icon	Description
 TestDrive EV-DO	TestDrive EV-DO Program
 TestDrive EV-DO Database Viewer	EV-DO results database viewer program (also available from within TestDrive EV-DO by selecting View Results from the Execute menu)
 TestDrive EV-DO User Manual	This is a PDF copy of this manual.
 TestDrive EV-DO Reference Manual	This is a PDF copy of the TestDrive EV-DO Test Reference Manual.

Start TestDrive EV-DO by clicking the EV-DO icon  shown in the TestDrive EV-DO group. The TestDrive EV-DO startup screen is shown in Figure 3-1.

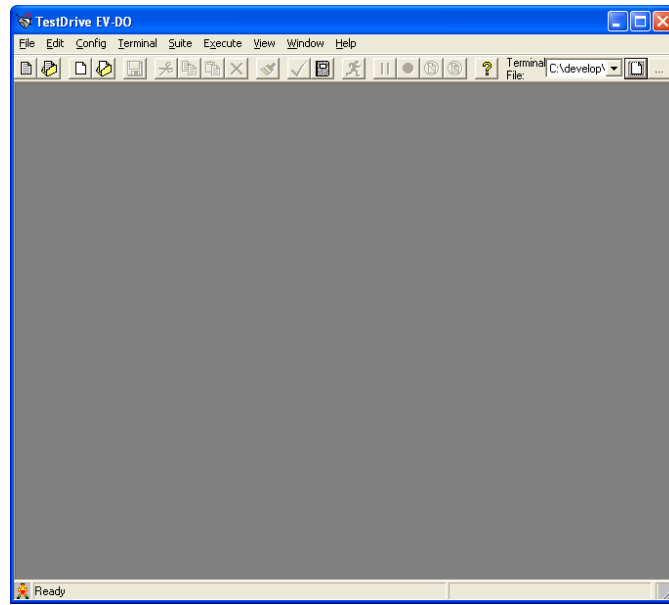


Figure 3-1: TestDrive EV-DO Window

3.3. Setting the Communications Options for the PC

Before communication between the PC and the instruments can take place, define certain parameters by selecting **Config>Instrument Config**.

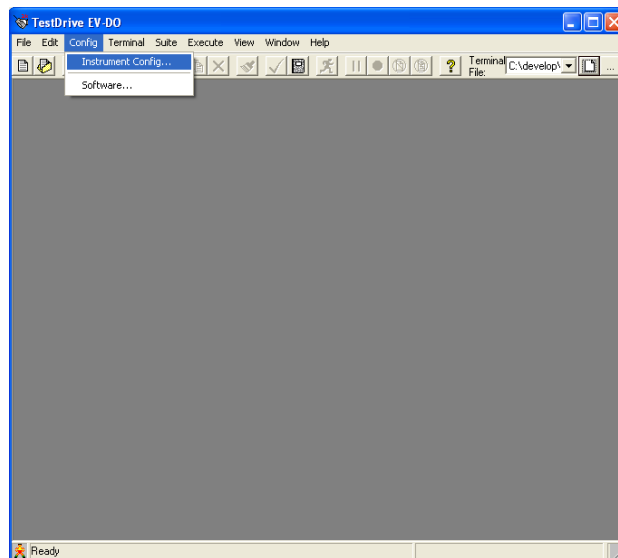


Figure 3-2: The Configuration Menu

3.3.1. Communication Settings

Before using TestDrive EV-DO, install the National Instruments GPIB card and test it using procedures outlined in **National Instrument's User Manual**. Verify that all instruments are set for GPIB remote protocol. Refer to the individual instrument manuals for information on setting the remote protocol. To display the Communication window, select **Config>Instrument Config**.

Instrument	GPIB Address	IP Address
☒ Agilent 8960 Main	14	
☐ Agilent 8960 Aux1	15	
☐ Agilent 8960 Aux2	16	
☐ Splitter		
☒ SR 5500		
☒ ESG1 4438	3	
☒ ESG2 4438	4	
☒ TAS 5048	9	
☒ SR 5068		
☐ SR 8048		192.168.0.200
☐ SR 8068		
☒ Spectrum Analyzer	18	
☒ Air Access C2K		

Buttons: OK, Cancel, Help, Verify Hardware, More Details >>>

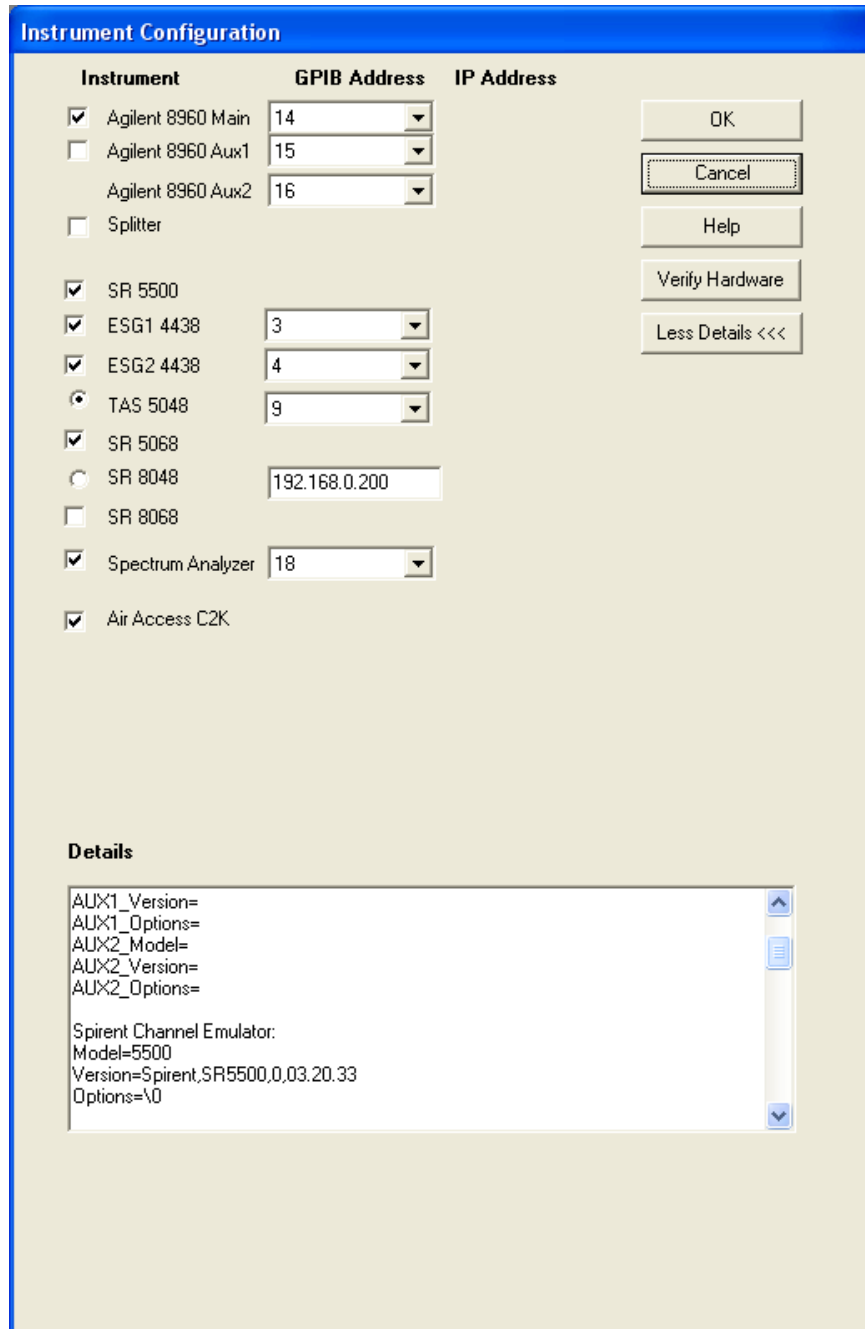
Figure 3-3: Instrument Parameters Window

Each instrument must have the following parameters set properly:

- **Present** – Check the checkbox next to the instrument name if it is connected to the system. Leave the instrument checkbox unchecked if it is not present.
- **GPIB Address** – Set each instrument's GPIB address to match the address that is set in the instrument.
- **IP Address** – Set each instrument's IP address to match the address that is set in the instrument

NOTE: *The SR5500 is controlled by Ethernet. TestDrive EV-DO assumes this instrument is configured for IP Address 192.168.0.7
****IP addresses are used only Rev B protocol tests.**

We recommend using the **Verify Hardware** button to allow TestDrive EV-DO to automatically verify the presence of the instruments and query the firmware version and hardware options of the instrument. TestDrive EV-DO looks for each enabled instrument at the selected GPIB Address or Ethernet address. Click the **More Details** button to display detailed information about the model, firmware version, and options for the instrument. Click the **Less Details** button to hide this information.



The Instrument Configuration window displays a list of instruments with their respective GPIB and IP addresses. The 'Details' section at the bottom provides specific information for the selected instrument, the Spirent Channel Emulator.

Instrument	GPIB Address	IP Address
☒ Agilent 8960 Main	14	
☐ Agilent 8960 Aux1	15	
☐ Agilent 8960 Aux2	16	
☐ Splitter		
☒ SR 5500		
☒ ESG1 4438	3	
☒ ESG2 4438	4	
☒ TAS 5048	9	
☒ SR 5068		
☐ SR 8048	192.168.0.200	
☐ SR 8068		
☒ Spectrum Analyzer	18	
☒ Air Access C2K		

Details

```

AUX1_Version=
AUX1_Options=
AUX2_Model=
AUX2_Version=
AUX2_Options=

Spirent Channel Emulator:
Model=5500
Version=Spirent,SR5500,0,03.20.33
Options=\0
  
```

Buttons: OK, Cancel, Help, Verify Hardware, Less Details <<<

Figure 3-4: Instrument Configuration Window – Details View

Click the **OK** button to store the instrument settings and return to the main window. Click the **Cancel** button to return to the main window without changing any instrument settings.

3.4. Configuring the Terminal Settings

To properly execute tests, TestDrive EV-DO needs information about the Access Terminal. This information is stored in a terminal file with a **.ter** extension. Each time TestDrive EV-DO is started, it attempts to load the previously used terminal file. The very first time TestDrive EV-DO is started, it loads the default terminal file.

The currently selected terminal file is displayed in the **Current Terminal** pull-down list on the toolbar. You can select a different terminal file from the pull-down list, by selecting **Terminal>Set Current Terminal**, or by clicking on the  button next to the textbox.

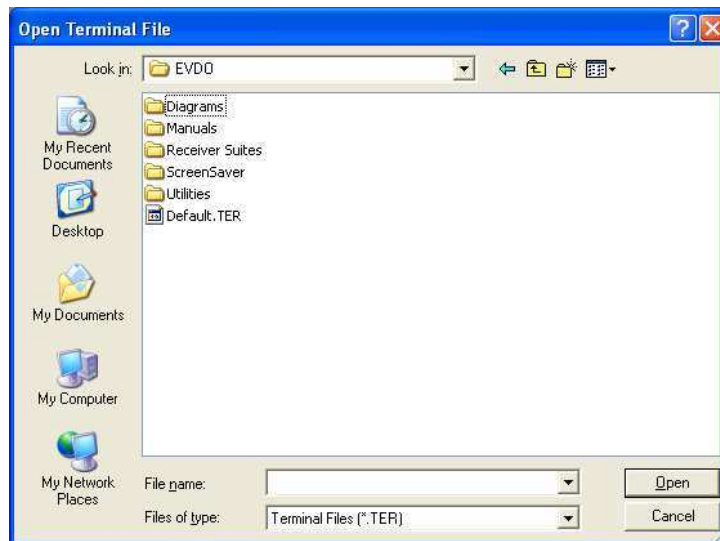


Figure 3-5: Open Terminal File Window

To view or edit the settings in the current terminal file, select **Terminal>View/Edit Terminal Settings**, or click the  button next to the textbox. The Terminal Settings window displays as shown in Figure 3-6.

Figure 3-6: Terminal Settings Window

When the settings are configured properly, click **Save** to save the changes in the terminal file. All the new settings overwrite the old settings in the file. To save the changes to a new file, click **Save As**. You can choose a new file to save the changes.

NOTE: TestDrive EV-DO does not allow you to save changes to the Default terminal file. TestDrive EV-DO notifies you of this. Click **OK** and choose a new file name to save the changes.

Clicking **Cancel** abandons all changes to the Terminal settings. Refer to Section 4.2, **Editing a Terminal File** on page 47 for detailed information on changing Terminal settings.

3.5. Loading a Pre-defined Test Suite

Load a pre-defined Test Suite by selecting the **Open Suite** icon  from the toolbar or by selecting **File>Open Suite**.

Open **Receiver Suites>AT-MPS>3.1.1.2.1 Demodulation of Forward Traffic Channel in AWGN.STE** directory as shown in Figure 3-7.

NOTE: EV-DO Rev A tests are categorized according to each chapter. So you would find the Rev A counterpart for the above test in the folder Chapter 3.



Figure 3-7: Open Suite File Window

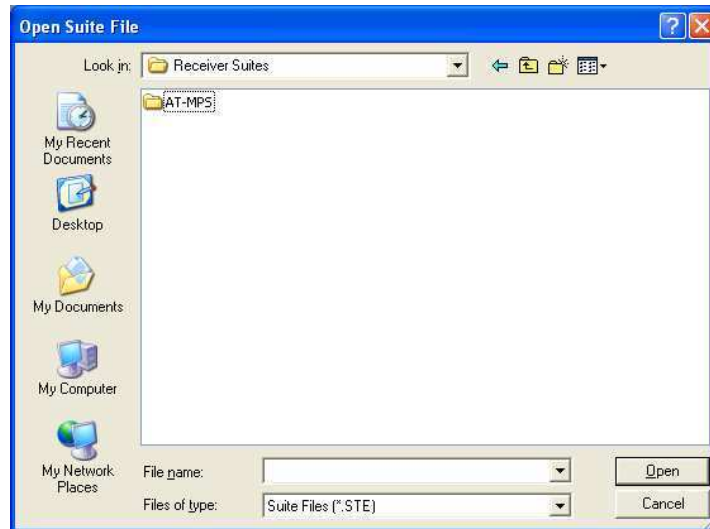


Figure 3-8: Open Suite File Window – Receiver Suites Folder

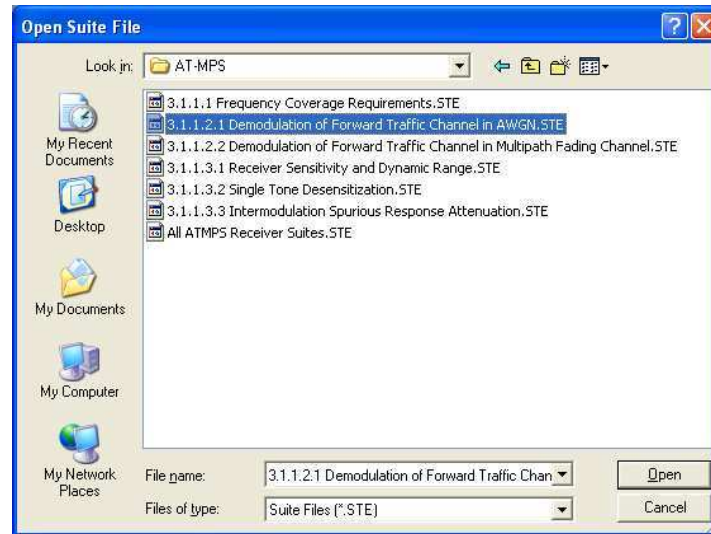


Figure 3-9: Open Suite File Window – AT-MPS Folder

Figure 3-10 shows the *Initial Suite* window.

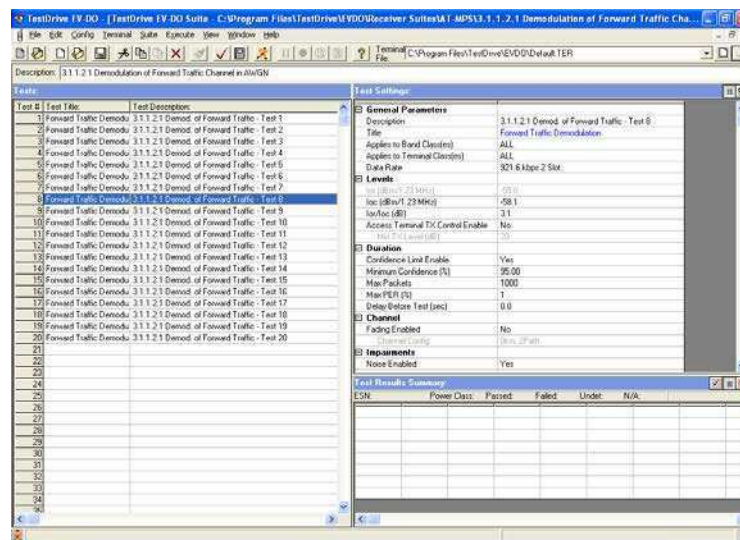


Figure 3-10: Initial Suite Window

The suite window is split between three viewing areas. In the left viewing area labeled **Tests**, all tests that are run in the current suite are listed. The selected test is highlighted in yellow. Once the suite is running, the currently executing test is highlighted in green. The top-right viewing area labeled **Test Settings** shows test parameters for the selected test in the Tests window. The bottom-right viewing area labeled **Test Results** shows the Validation Summary, Results Summary, or Error Summary. See Section 4.4., **Editing a Test Suite** on page 49 for information on how to modify the suite and the individual test settings.

3.6. Running a Test Suite

To run a Test Suite, select the **Run** icon  from the toolbar, or select **Execute>Perform Test Suite**. The *Execute Automatic Test* window displays, allowing you to set several run specific options.

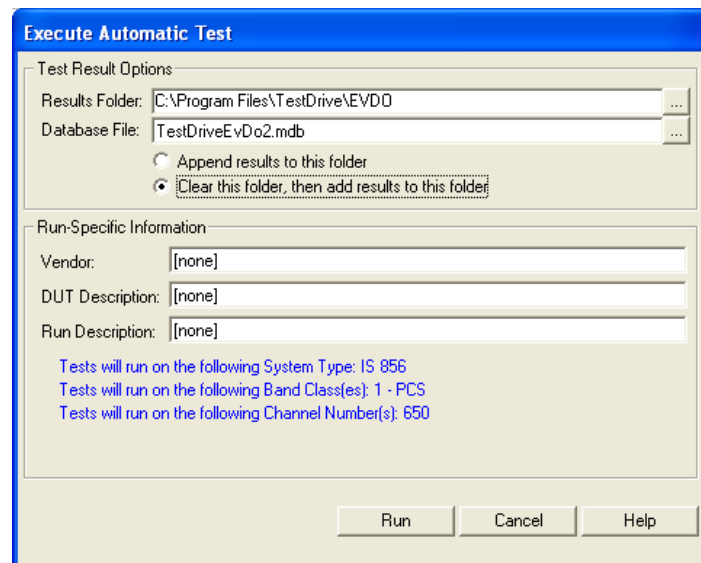


Figure 3-11: Execute Automatic Test Window

3.6.1. Test Result Options

The *Execute Automatic Test* window prompts you for the location of the **Results Path** in which to store the **Database File** which stores all test parameters and results. TestDrive EV-DO uses a Microsoft Access database format with a **.mdb** file extension. The **Database File Options** determine whether the database is cleared before any results are added.

3.6.2. Run-Specific Information

The *Run Specific Information* window allows you to enter a description of the Vendor, Device Under Test, and Run. This information is associated with the parameters and results of a specific test. It can be used to retrieve information from the database at a later time. The window also identifies specific Band Class(es), Radio Configuration(s) and Channel Number(s) for that test.

3.6.3. Switching Between Views

Switch the Validation Summary, Results Summary, and Errors Summary views at any time prior to or during test execution by clicking on the appropriate button . Validation occurs prior to test execution, so the Validation summary view is not updated during test execution. The Results summary and Errors summary are both updated in real-time during test execution.

The **Validate Summary** button  configures the bottom-right window to display validation messages. Validation messages display if you validate the suite, or if the **Always validate suites before execution** checkbox is checked in the **Software** menu.

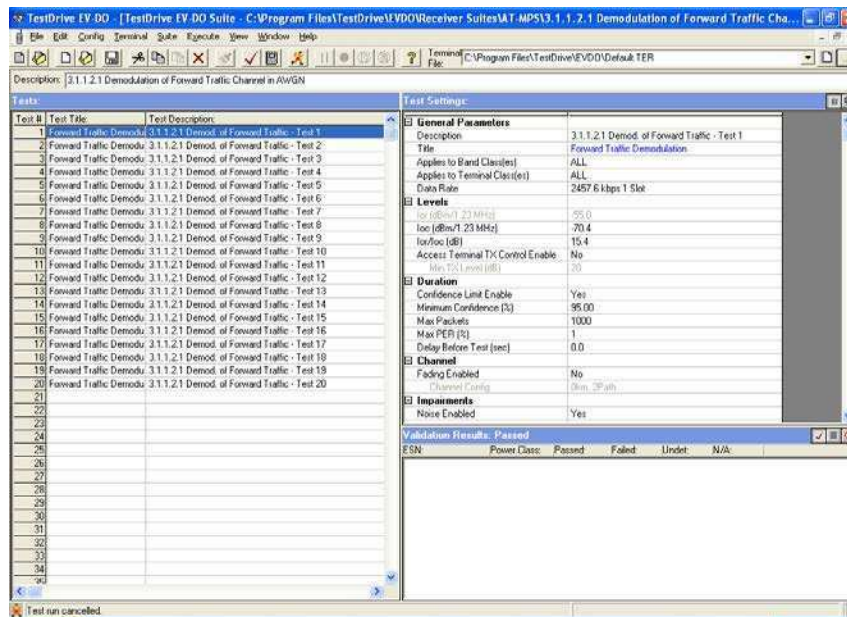


Figure 3-12: Test Suite Execution Window – Validation Message View

The **Results Summary** button  configures the bottom-right viewing area to display test results. Test results are displayed in real-time, with the current test results appearing on the last line of the grid. If the scrollbar is positioned at the bottom, the results grid auto-scrolls as tests are completed. If the scrollbar is moved from the bottom position, auto-scroll is disabled. This allows viewing of results for a particular test during execution. If a test status is **Pass**, the device passed the test. If the test status is **Fail**, the test was completed on the device, but the device did not meet or exceed the minimum passing criteria. If the test status is **Undt**, the test could not be performed due to test execution errors.

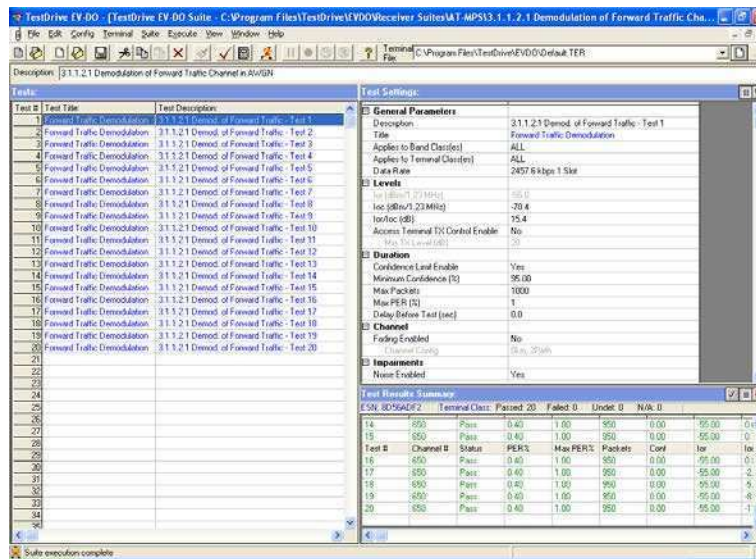


Figure 3-13: Test Suite Execution Window – Test Results Summary View

The **Errors Summary** button  configures the bottom-right viewing area to display test errors. Test errors are also displayed in real-time, with the current test error appearing on the last line of the grid.

In the upper right frame where **Test Settings** are shown, there are three icons used to switch views. The  icon is used only for Spurious Emissions Tests. Clicking on this icon displays a table of Frequency Sweep Segments. This table is used to specify frequency ranges and maximum levels used for spurious emissions sweeps. The  icon is used to view the test details setting. When a test is selected on the left hand grid the test settings displays on the right. The  icon is used to view the intermediate results. Clicking this icon while a suite is running displays detailed information about every test step.

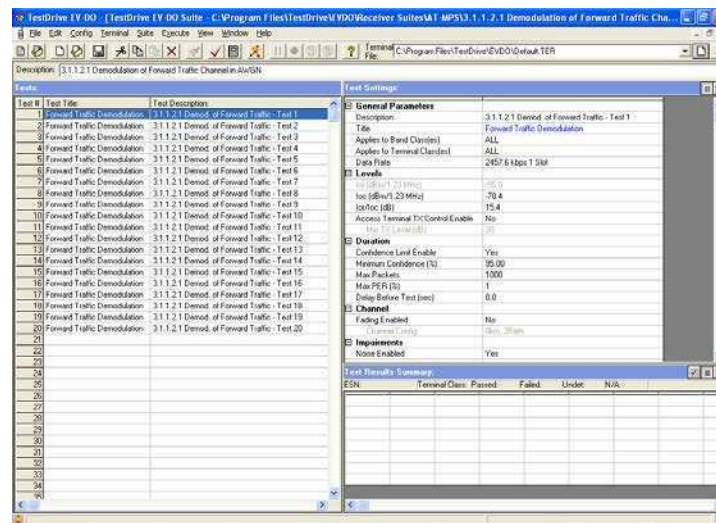


Figure 3-14: Test Suite Execution Window – Test Settings View

3.6.4. Halting Test Execution

TestDrive EV-DO provides three means of halting test execution:

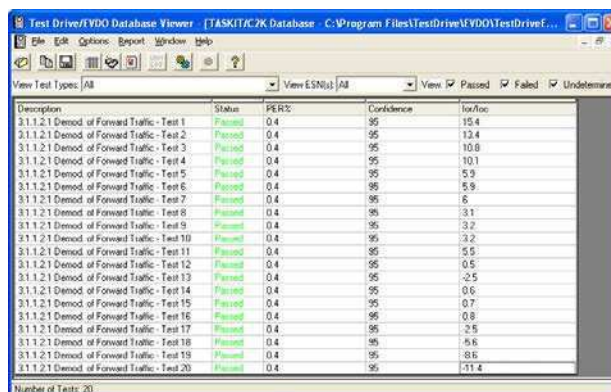
1. Clicking the **Cancel Test** button  or selecting **Execute>Cancel Test** cancels the current test only.
2. Clicking the **Cancel Suite** button  or selecting **Execute>Cancel Suite** cancels execution of the entire suite.
3. Clicking the **Pause** button  or selecting **Execute>Pause Execution** pauses the current test. When the test is paused, the Pause button changes to the Continue button , and the menu item changes to Continue Execution, either of which resumes the test execution. These buttons are found on the toolbar of the main window.

3.6.5. Viewing Test Results

After the Test Suite is run, the results may be viewed. This is done by selecting the **View Results** icon  from the toolbar or by selecting **Execute>Analyze Test Results** to start the **TestDrive EV-DO Database Viewer Application**.

The TestDrive EV-DO Database Viewer allows you to view the results stored in the Microsoft Access database file you selected in the Execute Automatic Test window. See Section 4.8,

EV-DO Database Viewer for a detailed explanation of how to use this application.



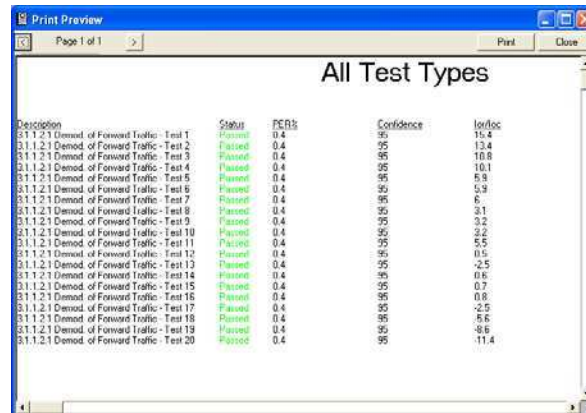
Description	Status	PER%	Confidence	Is/Ans
3.1.1.2.1 Demod of Forward Traffic - Test 1	Passed	0.4	95	15.4
3.1.1.2.1 Demod of Forward Traffic - Test 2	Passed	0.4	95	13.4
3.1.1.2.1 Demod of Forward Traffic - Test 3	Passed	0.4	95	10.8
3.1.1.2.1 Demod of Forward Traffic - Test 4	Passed	0.4	95	10.1
3.1.1.2.1 Demod of Forward Traffic - Test 5	Passed	0.4	95	5.9
3.1.1.2.1 Demod of Forward Traffic - Test 6	Passed	0.4	95	5.9
3.1.1.2.1 Demod of Forward Traffic - Test 7	Passed	0.4	95	6
3.1.1.2.1 Demod of Forward Traffic - Test 8	Passed	0.4	95	3.1
3.1.1.2.1 Demod of Forward Traffic - Test 9	Passed	0.4	95	3.2
3.1.1.2.1 Demod of Forward Traffic - Test 10	Passed	0.4	95	3.2
3.1.1.2.1 Demod of Forward Traffic - Test 11	Passed	0.4	95	5.5
3.1.1.2.1 Demod of Forward Traffic - Test 12	Passed	0.4	95	0.5
3.1.1.2.1 Demod of Forward Traffic - Test 13	Passed	0.4	95	-2.5
3.1.1.2.1 Demod of Forward Traffic - Test 14	Passed	0.4	95	0.6
3.1.1.2.1 Demod of Forward Traffic - Test 15	Passed	0.4	95	0.7
3.1.1.2.1 Demod of Forward Traffic - Test 16	Passed	0.4	95	0.8
3.1.1.2.1 Demod of Forward Traffic - Test 17	Passed	0.4	95	2.5
3.1.1.2.1 Demod of Forward Traffic - Test 18	Passed	0.4	95	5.6
3.1.1.2.1 Demod of Forward Traffic - Test 19	Passed	0.4	95	8.6
3.1.1.2.1 Demod of Forward Traffic - Test 20	Passed	0.4	95	11.4

Number of Tests: 20

Figure 3-15: EV-DO Database Viewer

3.6.6. Generating a Report

To generate a report, click the  button or select **Reports>Selected Field Report**. The following screen displays the report window. Click the **Print** button to print a copy of the report to your default printer. Refer to Section 4.12, **Report Types** on page 69 for more information on generating various types of reports.



The image shows a 'Print Preview' window titled 'All Test Types'. It contains a table with 5 columns: Description, Status, PERs, Confidence, and Latency. The table lists 20 test entries, all with a 'Passed' status. The window includes a 'Page 1 of 1' indicator, a 'Print' button, and a 'Close' button.

Description	Status	PERs	Confidence	Latency
3.1.1.2.1 Demod. of Forward Traffic - Test 1	Passed	0.4	95	15.4
3.1.1.2.1 Demod. of Forward Traffic - Test 2	Passed	0.4	95	13.4
3.1.1.2.1 Demod. of Forward Traffic - Test 3	Passed	0.4	95	10.8
3.1.1.2.1 Demod. of Forward Traffic - Test 4	Passed	0.4	95	10.1
3.1.1.2.1 Demod. of Forward Traffic - Test 5	Passed	0.4	95	5.8
3.1.1.2.1 Demod. of Forward Traffic - Test 6	Passed	0.4	95	5.9
3.1.1.2.1 Demod. of Forward Traffic - Test 7	Passed	0.4	95	6
3.1.1.2.1 Demod. of Forward Traffic - Test 8	Passed	0.4	95	3.1
3.1.1.2.1 Demod. of Forward Traffic - Test 9	Passed	0.4	95	3.2
3.1.1.2.1 Demod. of Forward Traffic - Test 10	Passed	0.4	95	2.2
3.1.1.2.1 Demod. of Forward Traffic - Test 11	Passed	0.4	95	5.5
3.1.1.2.1 Demod. of Forward Traffic - Test 12	Passed	0.4	95	0.5
3.1.1.2.1 Demod. of Forward Traffic - Test 13	Passed	0.4	95	-2.5
3.1.1.2.1 Demod. of Forward Traffic - Test 14	Passed	0.4	95	0.6
3.1.1.2.1 Demod. of Forward Traffic - Test 15	Passed	0.4	95	0.7
3.1.1.2.1 Demod. of Forward Traffic - Test 16	Passed	0.4	95	0.8
3.1.1.2.1 Demod. of Forward Traffic - Test 17	Passed	0.4	95	-2.5
3.1.1.2.1 Demod. of Forward Traffic - Test 18	Passed	0.4	95	5.6
3.1.1.2.1 Demod. of Forward Traffic - Test 19	Passed	0.4	95	-8.6
3.1.1.2.1 Demod. of Forward Traffic - Test 20	Passed	0.4	95	-11.4

Figure 3-16: Print Preview Window

4. Advanced Features

4.1. Overview

This chapter introduces the more advanced features of TestDrive EV-DO.

The items covered are:

- Editing a Terminal File
- Editing a Test Suite
- System Calibration
- Software Options
- Validating a Test Suite
- Working with Sessions
- TestDrive EV-DO Database Viewer
- Report Types

A pre-defined Test Suite from one of the standard AT-MPS Receiver Tests is used to illustrate the advanced features of TestDrive EV-DO. Start TestDrive EV-DO and verify that the PC communications options and the hardware setups for the instruments are correctly configured. After the configurations are verified, load the following Test Suite:

Receiver Tests>AT-MPS>3.1.1.2.1 Demodulation of Forward Traffic Channel in AWGN.STE

4.2. Editing a Terminal File

TestDrive EV-DO uses a Terminal file for storage and retrieval of Terminal specific parameters. These parameters are necessary to ensure proper execution of each test in a suite. When a suite is executed, the Terminal parameters are read from the current terminal file. To choose a different terminal file, select **Terminal>Set Current Terminal** from the Terminal menu, or select a Terminal from the Current Terminal pull-down list.

You can also click on the  button on the right side of the toolbar and select the Terminal file from the window.

To edit the current Terminal parameters, select **Terminal>View/Edit Terminal Settings**, or click the  button on the toolbar. The *Edit Terminal File* window displays as shown in Figure 4-1.

TestDrive EV-DO Terminal - C:\Develop\TASKIT\EV-DO\3.00\SOURCE\default.ter

Terminal Settings:

General Parameters

Description	
System Type	IS 856
Channel Number	650
Channel Number(s) for Test	650
Repeat for Call Setup Channels	No
Call Setup Channels	283
Band Class	0 - Cellular
ESN	
Antenna Gain (dB)	0.0
Terminal Class	Class 3

Data Connection Setup

Minimum Connect Setup Level (dBm)	-90.0
Connect Retry	Yes
Connect Retry Delay (sec)	1
Connect Retry Max	5
Connect Timeout (sec)	20

Primary Antenna Loss:

#	Forward Freq (MHz)	Forward Loss (dB)	Reverse Freq (MHz)	Reverse Loss (dB)
1	800	1.0	800	1.0
2	850	1.0	850	1.0
3	900	1.0	900	1.0
4	950	1.0	950	1.0
5	1700	1.0	1700	1.0
6	1800	1.0	1800	1.0
7	1900	1.0	1900	1.0
8	2000	1.0	2000	1.0
9				
10				
11				
12				
13				
14				
15				

Secondary Antenna Loss:

#	Forward Freq (MHz)	Forward Loss (dB)	Reverse Freq (MHz)	Reverse Loss (dB)
1	800	1.0	800	1.0
2	850	1.0	850	1.0
3	900	1.0	900	1.0
4	950	1.0	950	1.0
5	1700	1.0	1700	1.0
6	1800	1.0	1800	1.0
7	1900	1.0	1900	1.0
8	2000	1.0	2000	1.0
9				
10				
11				
12				
13				

Buttons: Save As, Save, Close, Help

Figure 4-1: Edit Terminal File Window

The current Terminal file is indicated in the Title bar. Make adjustments to the settings in this window for the Terminal in use. When you are finished, click the **Save** button to save the new settings in the Terminal file. If you want to save your settings to a different Terminal file, click the **Save As** button. Click **Cancel** to abandon any changes.

NOTE: TestDrive EV-DO does not allow you to save changes to the Default terminal file. If you attempt to do this, TestDrive EV-DO indicates the problem. Click OK and choose a new file name to save the changes.

When TestDrive EV-DO is closed, it keeps track of the last used terminal file. The next time it is started, it loads the same terminal file as the current terminal file.

4.3. Setting Terminal Parameters

Terminal parameters can be edited in the same manner as test parameters. Parameters with a numeric range allow any value in range to be entered. Parameters that can only be set to a specific set of values allow only these values to be selected from a drop-down control.

4.4.1. Adding a Test

Each test in a suite can be one of several different test types. Different tests measure different performance criteria. A unique set of parameters applies to each test type. Each test type and their associated parameters are described in detail later in this chapter.

When adding a new test, use the following steps to select a test type:

1. Click a blank cell in the Test Title column of the *Suite* window.
2. Click the cell again to show the Test Types menu.
3. Select the desired test type from the menus.

NOTE: Once you have selected a test type for a particular test you cannot change it. You can delete the test to make the cell blank and then use the steps above to create a new test.

The parameters of each Test File can be edited in the **Test Settings** window in the upper-right pane of the suite window. The Test Settings window lists the available parameters for the selected test in the **Tests** pane. The test selected in the test pane is highlighted in blue.

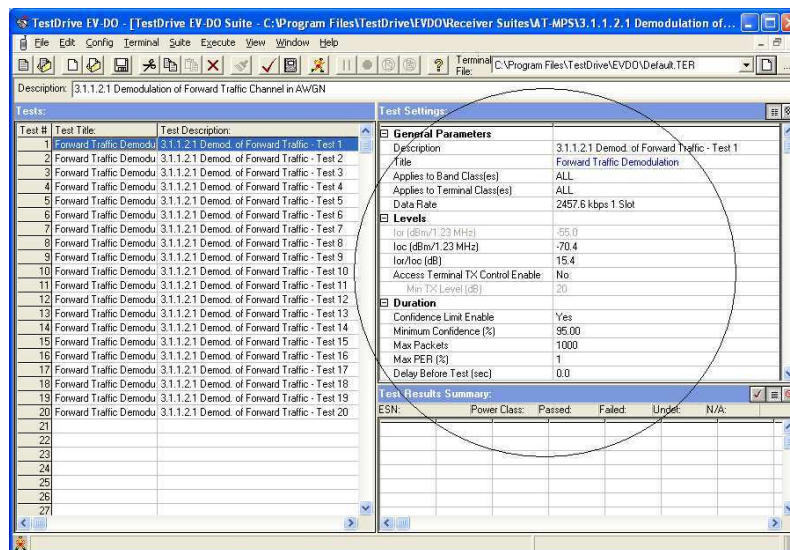


Figure 4-3: Tests Pane

The fields in the Test Settings window are divided into several groups of related parameters. Each of these groups has parameter fields that can be edited before the test is executed. The parameter labels are based directly on those found in the 3GPP2 C.S0033 AT-MPS test standard. The method of editing each parameter depends on its field type. There are two basic field types: **Text box** fields, and **List box** fields. Text box fields apply to parameters whose values may be within a specific range, usually numeric. List box fields apply to parameters whose values are restricted to a specific set.

To edit a parameter:

1. Click once on the desired parameter value to select it.
2. Click the parameter again to edit.
3. Depending on the parameter type, you can enter a value directly, or select from a list of valid values.

Clicking on a parameter contained in a text box field highlights the current value. A new value can now be entered. Pressing enter accepts the new value. If the new value is out of range, TestDrive EV-DO resets the old value and displays the valid range.

General Parameters	
Description	3.1.1.2.1 Demod. of Forward Traffic - Test 1
Title	Forward Traffic Demodulation
Applies to Band Class(es)	ALL
Applies to Terminal Class(es)	ALL
Data Rate	2457.6 kbps 1 Slot
Levels	
Ior (dBm/1.23 MHz)	-55.0
Ioc (dBm/1.23 MHz)	-70.4
Ior/Ioc (dB)	15.4
Access Terminal TX Control Enable	No
Min TX Level (dB)	20
Duration	
Confidence Limit Enable	Yes
Minimum Confidence (%)	95.00
Max Packets	1000
Max PER (%)	1
Delay Before Test (sec)	0.0

Figure 4-4: Editing a Parameter

Clicking on a parameter contained in a list box brings a list of all available values. Clicking on the desired value sets the parameter to the new value.

General Parameters	
Description	3.1.1.2.1 Demod. of Forward Traffic - Test 1
Title	Forward Traffic Demodulation
Applies to Band Class(es)	ALL
Applies to Terminal Class(es)	ALL
Data Rate	2457.6 kbps 1 Slot
Levels	
Ior (dBm/1.23 MHz)	307.2 kbps 4 Slot
Ioc (dBm/1.23 MHz)	614.4 kbps 1 Slot
Ior/Ioc (dB)	614.4 kbps 2 Slot
Access Terminal TX Control Enable	921.6 kbps 2 Slot
Min TX Level (dB)	1228.8 kbps 1 Slot
Duration	
Confidence Limit Enable	Yes
Minimum Confidence (%)	95.00
Max Packets	1000
Max PER (%)	1
Delay Before Test (sec)	0.0

Figure 4-5: Parameter Drop-down List

4.4.2. **Group Edit**

If you want to set a parameter to the same value in more than one test, you can use the **Group Edit** feature. For example, you may want to set Ior to -90 dBm for tests 1 through 20. Group Edit makes setting values in multiple tests easy and convenient.

TestDrive EV-DO allows you to select more than one test at a time. To do this, click and hold the mouse on the first test you wish to select in the Test grid. Then drag the mouse pointer to the last test that you wish to select. You can accomplish the same selection by using the shift key. Click on the first test of the group you wish to select. Hold down the shift key and click on the last test in the group.

Similarly, you can select tests by holding down the control key and clicking on the individual tests you wish to edit. The tests selected do not need to be in a contiguous block when selections are made in this manner.

Once you have your group of tests selected, you can make changes to the test parameters. If a parameter setting is blank, it means that it is different across the tests in the group. If you set a parameter, it affects that parameter in every test in the group to the value you enter. Some parameters may not apply to every test selected. In this case, the parameter setting only applies to those tests that support that parameter.

4.4.3. **Parameter Sweep**

If you want to execute a test repeatedly while a parameter is slowly changed for each repetition, you can use the **Parameter Sweep** feature. For example, you can repeatedly execute a PER test while Ioc is adjusted incrementally for each test. The Parameter Sweep feature simplifies this task by building a suite of tests based on your criteria.

To use this feature, it is best to start with a new suite. Add a new test as test 1. Select the test type you wish to perform. Modify the test parameters accordingly. When you are finished, click on the parameter you wish to increase or decrease. You may only select one parameter.

With the parameter selected, select **Edit>Sweep** from the Edit menu, or click on the broom icon. The Sweep window displays. Enter the start, stop, and increment values appropriately. TestDrive EV-DO indicates the legal range for the parameter and calculates the number of tests to be added to the suite.

You can choose to have the Description for each test appended with the parameter sweep information. This is useful when analyzing the results later. When you click the **OK** button, TestDrive EV-DO adds the calculated number of tests to the suite. The parameters across all tests are identical except the parameter to be swept. Its value changes for each test appropriately.

4.5. System Calibration

TestDrive EV-DO includes an automated calibration procedure to achieve high accuracy for power levels at various points in the system. When TestDrive EV-DO is executed for the first time, default calibration data is loaded into memory. This data is available until you run the calibration procedure for the first time. It is recommended that the calibration procedure is executed when the system is first installed, and once every six months thereafter.

To ensure the accuracy of the measurements taken during system calibration it is suggested that the spectrum analyzer calibration procedure be run prior to running system calibration. If the system has an ESA spectrum analyzer run the calibration procedure outlined in the **Agilent ESA Spectrum Analyzers User's Guide**. If using an 8590 series spectrum analyzer, run the calibration procedure outlined in the **Agilent 8590 E-Series and L-Series Spectrum Analyzers User's Guide**.

To execute the System Calibration procedure, select **Execute>System Calibration**. This launches the TestDrive EV-DO Calibration Wizard displayed in the screen below. During the calibration procedure, it is necessary for an operator to re-configure some of the RF cables. The entire procedure requires approximately 5 to 45 minutes to complete, depending on the instruments present in the system.

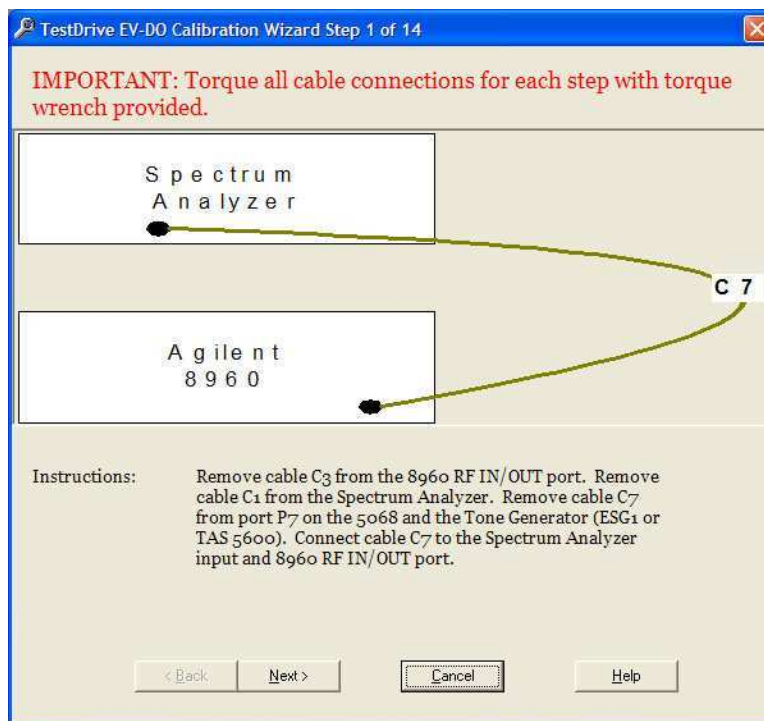


Figure 4-6: Calibration Wizard Window

4.5.1. Performing a Calibration

To perform a system calibration:

1. Configure the RF cables as specified by the Instructions in the *Calibration Wizard* window.
Make sure to use the proper cables for each step of the procedure. Each cable should be clearly labeled with a tag (e.g. cable #1 is labeled C1, etc).
2. Click the **Next** button to initiate measurements. The **Progress Bar** displays the text **Calibrating** indicating that the procedure is executing.
3. When the calibration step is complete, a new diagram displays. When the Progress Bar displays the text, **Waiting For User**, proceed to the next step.

When the calibration procedure is completed, the following message window displays.

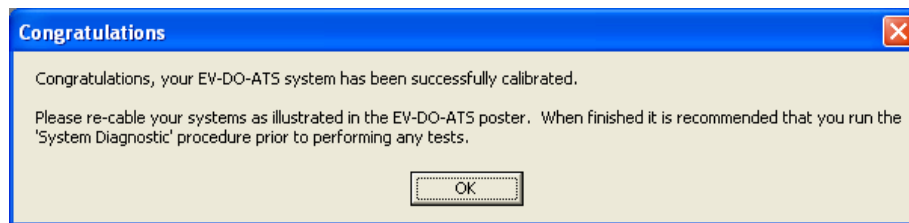


Figure 4-7: Calibration Confirmation Window

This indicates that the new calibration data has been verified and is saved to the system registry for future use. At this point it is necessary to re-cable the system as indicated in the system Setup Guide. We recommend you execute the **System Diagnostic** procedure prior to executing any new tests. Refer to Section 5.2, **System Diagnostics** on page 84 for details.

4.6. Software Options

To set the Software Options, select **Options>Software**. The *Software Options* window displays. This window contains fields that allow you to save your preferences for the Default File Location, User Name, User Initials, and Company Name.

Comm Log Type can be set to None, Fail-Safe, or Fast. For fastest execution, set this parameter to **None**. Setting this to a value other than None creates a record of all instrument transactions in a file. Setting the Comm Log Type parameter to **Fail-Safe** writes to the **comm. log** after each transaction. This is the slowest method, but it ensures that all commands are recorded in the event of a failure. Setting this parameter to **Fast** writes to the **comm. log** in bursts. This speeds up execution at the cost of losing some instrument transactions in the event of a failure. The **comm. log** file is called **CDMACOMM.LOG** and is located in the same directory as the current database file.

Selecting the first check box tells TestDrive EV-DO to always run in demonstration mode. Demonstration Mode simulates TestDrive EV-DO execution; it does not send commands to the instruments.

Selecting the second check box tells TestDrive EV-DO to automatically validate suites prior to execution. Validation errors cause suite execution to halt. Validating checks to make sure test parameters are valid.

Selecting the third checkbox allows you to hide the path information for file names that display in grids throughout the software.

The Mail-Notification options enable you to get a status update when a suite or a session completes execution, or a notification when a test fails or achieves “Undetermined” status. Note that this feature depends on network and server configuration settings not completely controlled by TestDrive EV-DO. If there is a problem receiving the notification, check with your network administrator. This feature uses the standard mail functionalities of Microsoft Outlook and its configuration affects this feature.

The Password Protection option allows you to prevent anyone from modifying a session/suite setting without password verification. When the option is selected, you can continue modify the session/suite until the program is closed. On restarting the program, a window displays requiring the password to allow suite modification, if no password is given, the program continues in read-only mode.

You can also deselect this option and provide the password in the *Software Options* window to enable the session/suite modification. If a password is entered incorrectly 3 times, the program executes in a read-only mode.

The default password is “admin” and can be changed using the Change Password option.

The Auto-Retry options allow you to selectively run any tests that fail or otherwise achieve an “Undetermined” status due to various factors such as a faulty instrument configuration, or unexpected errors with the mobile. A test that fails or achieves “Undetermined” status, is run immediately for a fixed number of times as specified in the *Software Options* window shown in Figure 4-8.

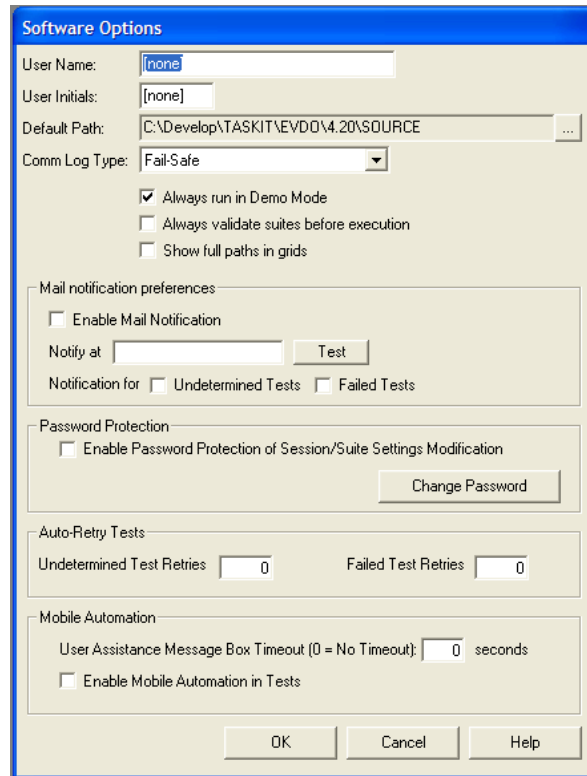


Figure 4-8: Software Options Window

4.7. Validating a Test Suite

Before running a Test Suite it should be validated to help avoid test execution errors. TestDrive EV-DO will analyze an entire suite for test setup and parameter value problems before it is executed. Validation checks test conditions against the current system configuration and alert the you if the system does not contain sufficient hardware to perform certain tests. Although this does not guarantee flawless execution, it significantly reduces the risk of problems during execution by detecting them beforehand.

To validate the Test Suite select the **Validate Suite** icon  from the Tool Bar or select the **Execute>Validate Suite**.

In the example shown below, errors were found. After Validating the Suite, all validation messages can be viewed by clicking the **Check** button in the bottom-right pane of the suite window.

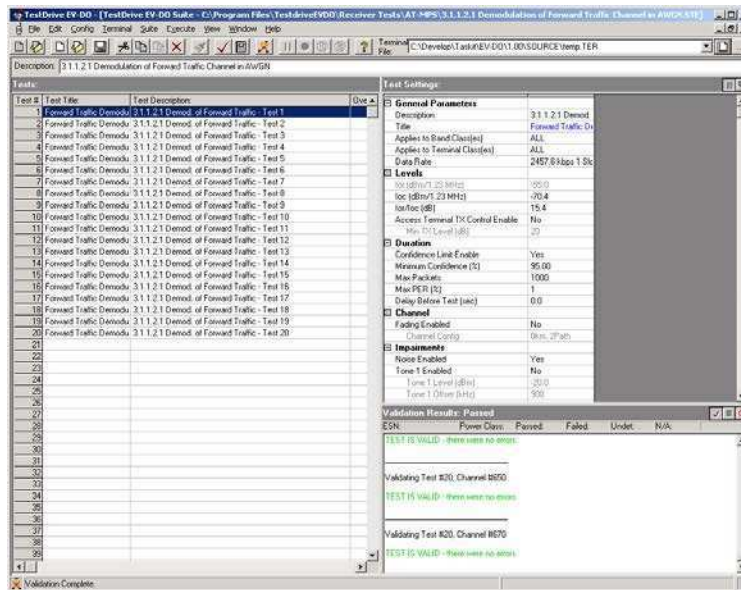


Figure 4-9: Test Suite Window with Errors

4.8. Working with Sessions

A Session is a group of suites. To create a new session, select **File>New Session**, or click the  button. The *Test Session* window is shown in Figure 4-10.

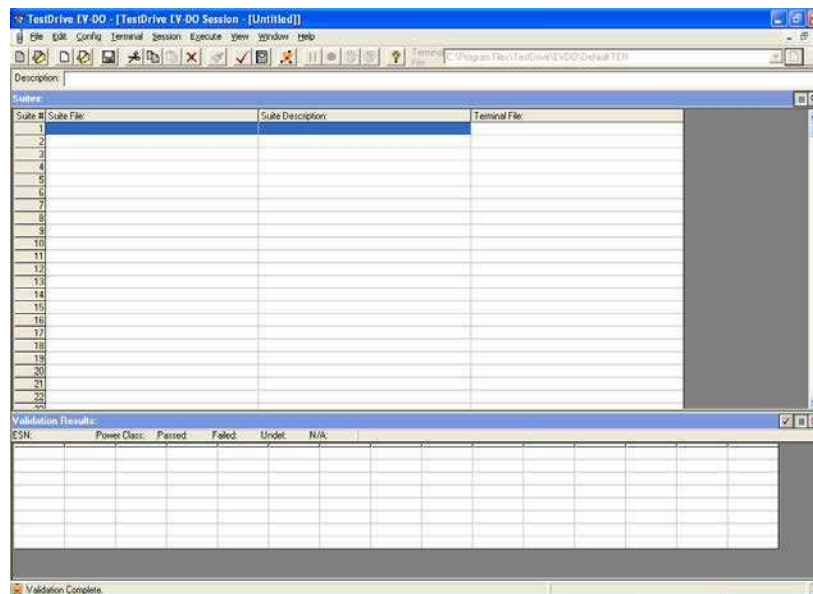


Figure 4-10: Test Session Window

A Session allows you to collect related Suites into one group and run them one after the other. To insert a Suite into the Session grid, double-click on a cell in the **Suite File** column. This action recalls a window that allows you to select a suite file. In the example shown in the following screen, suites from the receiver tests\AT-MPS directory are being opened into the session.

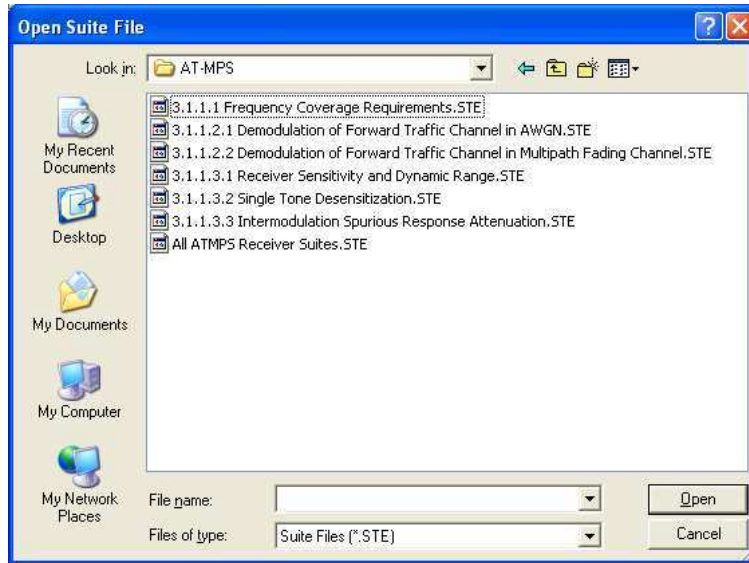


Figure 4-11: Open Suite File Window – Selecting Groups

When a Suite is opened into a Session, a description of the Suite is read from the file and displayed in the **Suite Description** column. You cannot directly edit the Suite or its description from the Session; you can only do so through the suite window. This can be done by holding the **Control** key and double-clicking on the **Suite** file in the **Session Grid**. Changes made to the Suite must be saved before they are accepted by the Session.

You can adjust the width of the columns in the session by dragging the column separator. This allows you to view long file names in the grid.

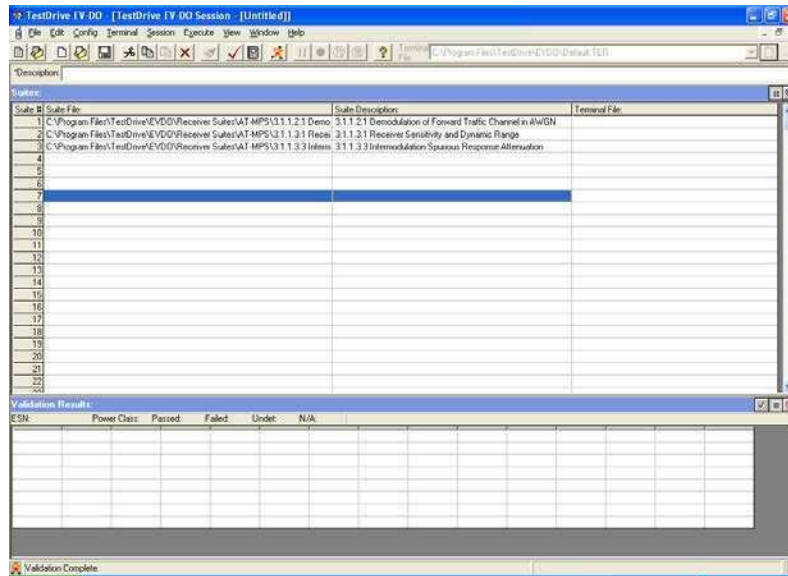


Figure 4-12: Adjusting Column Width

A Terminal file must be specified for each Suite within the Session by double-clicking on the cell in the **Terminal File** column. This recalls a window that allows you to select a terminal file (*.ter) as shown in the following screen. The Terminal File can be viewed in a window by holding in the **Control** key and double-clicking on the file in the Terminal File column in the Session grid.

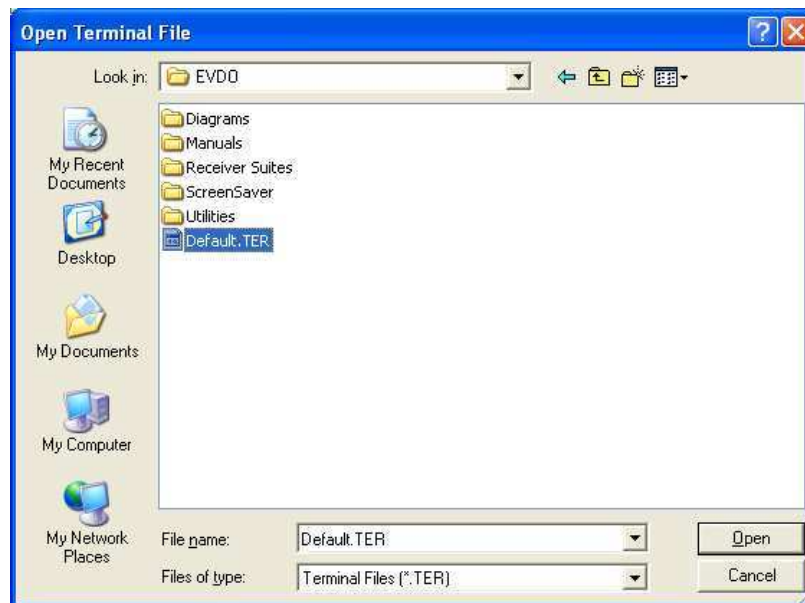


Figure 4-13: Open Terminal File Window

TestDrive EV-DO does not allow you to execute a Session unless you specify a terminal file for each line in the Session.

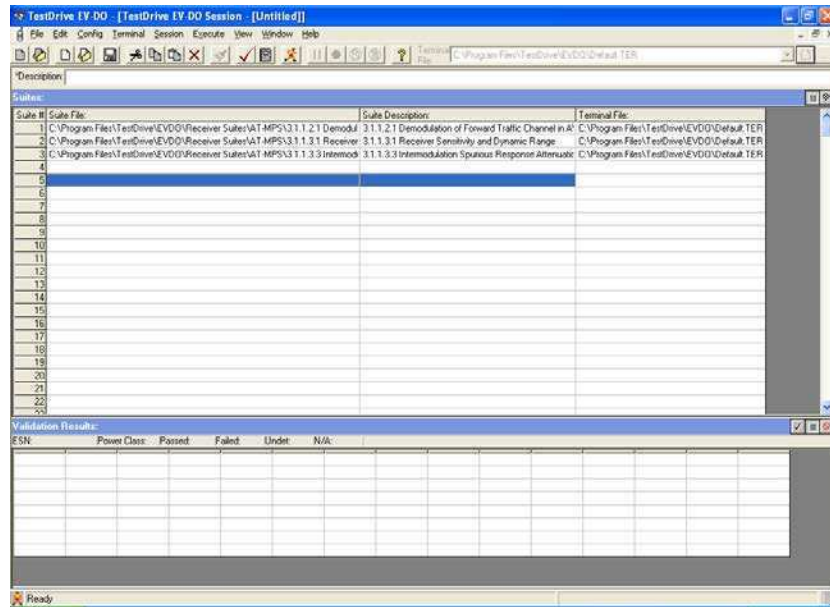


Figure 4-14: Test Session Window – Session Grid

The Session grid supports group cut, copy, paste, and delete operations except for in the Suite Description column. You cannot modify this column directly because it is paired with the Suite File. When you cut, copy, paste, or delete a Suite, the description is paired with it.

Any Suite Files or Terminal Files that have errors, such as file not found, are displayed in red in the grid. The error message is displayed in the Description. You have the option of re-specifying the file or deleting it.

WARNING: The Session file contains the file paths and names of all the Suite and Terminal files it contains. If you move or rename the Suite and/or Terminal Files pointed to by the Session File, the Session will not find them. If this happens, you need to re-specify all the moved/renamed files in the Session.

- Save a Session by clicking the  button or selecting **File>Save**. Session files have the extension *.csn. Open a Session file by clicking on the  button or selecting **File>Open Session**.

4.9. Validating and Running a Session

Validate a Session by clicking the  button, or selecting **Execute>Validate Test Session**. Session validation can take a long time because it must load each Suite from disk and then run a validation on each Suite.

Once you have created the Session, run the session by clicking the  button, or select **Execute>Perform Test Session**. The *Execute Automatic Test* window displays as shown below. This window allows you to select the location of the database and whether to overwrite this database or append to it.

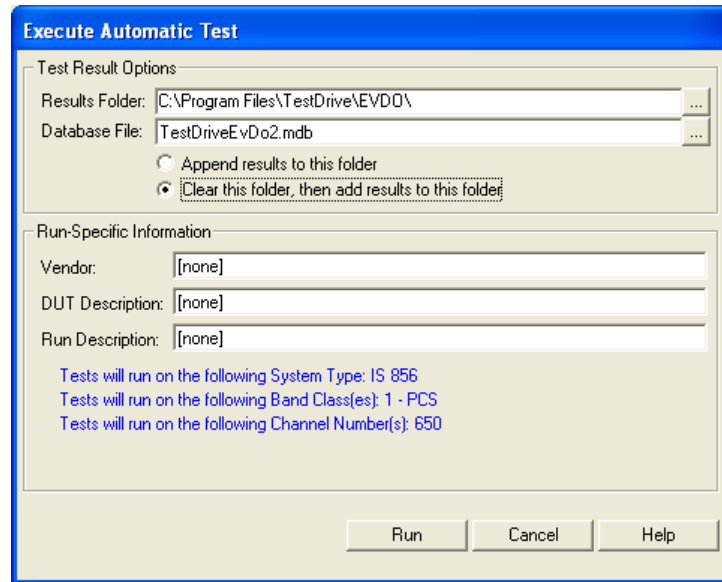


Figure 4-15: Test Session Execute Automatic Test Window

The *Execution* window for sessions contains the same information as for a suite. Refer to Section 3.5, **Running a Test Suite** on page 41 for a description of the features of the Execute Automatic Test window.

The *Run Specific Information* window allows you to enter a description of the Vendor, Device Under Test, and Run to be entered. This information is associated with the parameters and results of a specific test. This information can be used to retrieve information from the database at a later time. The specific System type, Band Class(es), and Channel Number(s) that the test performs on are also identified.

Execute the Session from this window by clicking the **Run** button. The Session loads the first Suite and proceeds to execute one suite at a time in ascending order. Once a suite completes running, it is removed from memory and the next suite is loaded and executed.

The lower half of the Session window contains three views: Validation Summary, Results Summary, and Errors Summary. These views are updated at various stages of Session execution.

The Validation Summary, Results Summary, and Errors Summary views can be switched at any time prior to or during test execution by clicking on the appropriate button . Validation occurs prior to test execution, so the Validation summary view is not updated during test execution. The Results summary and Errors summary are both updated in real-time during test execution.

4.10. Controlling Session Execution

The button group on the toolbar of the main window  controls the execution of the Session. The **Pause** button  pauses the currently executing test. It toggles to **Resume** , which resumes test execution when clicked. The **Stop** button  stops the currently executing test, and begins executing the next test in the current suite. The **Cancel Suite** button  cancels the currently executing suite and begins executing the next suite in the session. The **Cancel Session** button  cancels the session entirely.

4.11. EV-DO Database Viewer

The **EV-DO Database Viewer** is a stand-alone application that allows you to retrieve, view, and print test results. The EV-DO Database Viewer can be accessed from TestDrive EV-DO by clicking on the **View Results** icon  or by starting it from the Windows Start menu. The following image shows the EV-DO Database Viewer main screen.

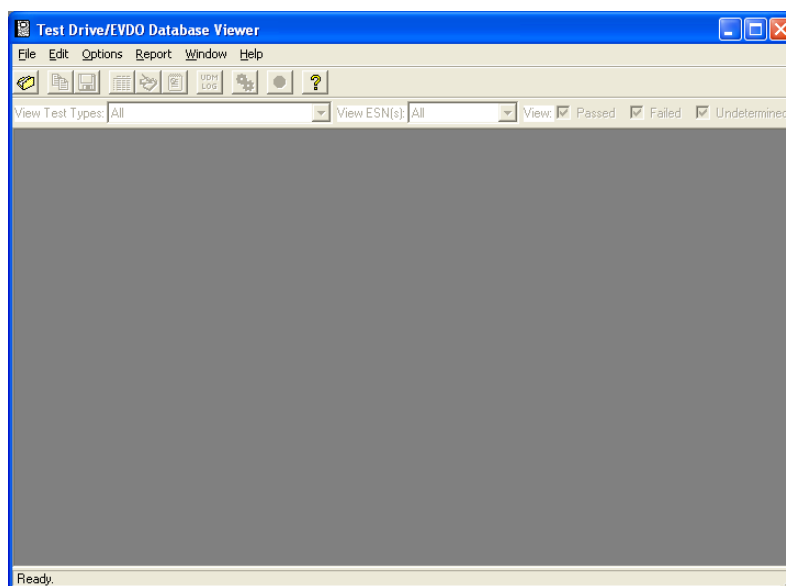


Figure 4-16: EV-DO Database Viewer Window

To open a database, choose **File>Open** or click the  button in the toolbar. Select the database file from the *Open File* window, as shown in Figure 4-17.



Figure 4-17: Open Database File Window

TestDrive EV-DO stores test results in a Microsoft Access database with the file extension **.mdb**. The following image shows the database opened in the EV-DO Database Viewer application.

Description	Status	PER%	Confidence	Ior/loc
3.1.1.2.1 Demod. of Forward Traffic - Test 1	Passed	0.4	95	15.4
3.1.1.2.1 Demod. of Forward Traffic - Test 2	Passed	0.4	95	13.4
3.1.1.2.1 Demod. of Forward Traffic - Test 3	Passed	0.4	95	10.8
3.1.1.2.1 Demod. of Forward Traffic - Test 4	Passed	0.4	95	10.1
3.1.1.2.1 Demod. of Forward Traffic - Test 5	Passed	0.4	95	5.9
3.1.1.2.1 Demod. of Forward Traffic - Test 6	Passed	0.4	95	5.9
3.1.1.2.1 Demod. of Forward Traffic - Test 7	Passed	0.4	95	6
3.1.1.2.1 Demod. of Forward Traffic - Test 8	Passed	0.4	95	3.1
3.1.1.2.1 Demod. of Forward Traffic - Test 9	Passed	0.4	95	3.2
3.1.1.2.1 Demod. of Forward Traffic - Test 10	Passed	0.4	95	3.2
3.1.1.2.1 Demod. of Forward Traffic - Test 11	Passed	0.4	95	5.5
3.1.1.2.1 Demod. of Forward Traffic - Test 12	Passed	0.4	95	0.5
3.1.1.2.1 Demod. of Forward Traffic - Test 13	Passed	0.4	95	-2.5
3.1.1.2.1 Demod. of Forward Traffic - Test 14	Passed	0.4	95	0.6
3.1.1.2.1 Demod. of Forward Traffic - Test 15	Passed	0.4	95	0.7
3.1.1.2.1 Demod. of Forward Traffic - Test 16	Passed	0.4	95	0.8
3.1.1.2.1 Demod. of Forward Traffic - Test 17	Passed	0.4	95	-2.5
3.1.1.2.1 Demod. of Forward Traffic - Test 18	Passed	0.4	95	-5.6
3.1.1.2.1 Demod. of Forward Traffic - Test 19	Passed	0.4	95	-8.6
3.1.1.2.1 Demod. of Forward Traffic - Test 20	Passed	0.4	95	-11.4

Figure 4-18: Opened Database

4.11.1. Database Viewer Toolbars

The following list describes the Database Viewer toolbars. The top toolbar contains buttons which duplicate many of the menu items. The bottom toolbar restricts the data to common items of interest.



Open Database File

Opens a database file.



Copy Data to Windows Clipboard

Copies all data to the Windows clipboard. This is useful for pasting the data into another application, such as a spreadsheet.



Save to Spreadsheet Compatible File

Saves all data to a spreadsheet compatible file. The file is saved as tab-delimited text with an .xls extension. This file can be opened in Microsoft Excel.



Report on Selected Fields

Generates a print preview window of the data. The Print Preview window can then be sent to the printer.



Report on All Parameters and Results

Generates a report on all test details and results of all the tests shown in the database grid.



Report on Test Errors

Generates a report on all errors that occurred for all the tests shown in the database grid.



Suite and Session Statistics

Generates a report that summarizes the total run time of each suite or session available in the database.



PDF Viewer

Generates the report for the selected test in PDF format. Note that this button is enabled only when the PDF995 software is detected on the host system.



Modify Fields

Recalls the Field Selection window. This window allows the columns shown in the database grid to be modified. Data fields can be added or removed through this window.



Stop Data

Stops access to the database. In the event that data retrieval is taking a long amount of time, this button will stop the process. This allows the data to be restricted so that a fewer number of records are retrieved from the database.



Help

Launches the help application.

View Test Types: All ▼

View Test Types List

Restricts the data to a given test type. When “All” is selected, there is no test type restriction.

View Hardware ID(s): All ▼

View Hardware ID(s) List

Restricts the data to a given Terminal Hardware ID. All Hardware ID s stored in the database are retrieved and put into this list. When “All” is selected, there is no Hardware ID restriction.

☒ Passed

View Tests that Passed

Restricts the data to tests that passed. Un-checking this checkbox will remove all “passed” tests from the database grid.

View Tests that Failed

Restricts the data to tests that failed. Un-checking this checkbox will remove all “failed” tests from the database grid.

☒ Undetermined

View Tests that were Undetermined

Restricts the data to tests that were undetermined. Un-checking this checkbox will remove all “undetermined” tests from the database grid.

The status bar at the bottom of the main window updates periodically to give information as to what operations are being performed. The total number of test records retrieved from the database is displayed when the database access operation is complete.

4.11.2. Field Selection Window

Use the *Field Selection* window as shown in Figure 4-19, to include or exclude individual data fields from being shown in the database grid.

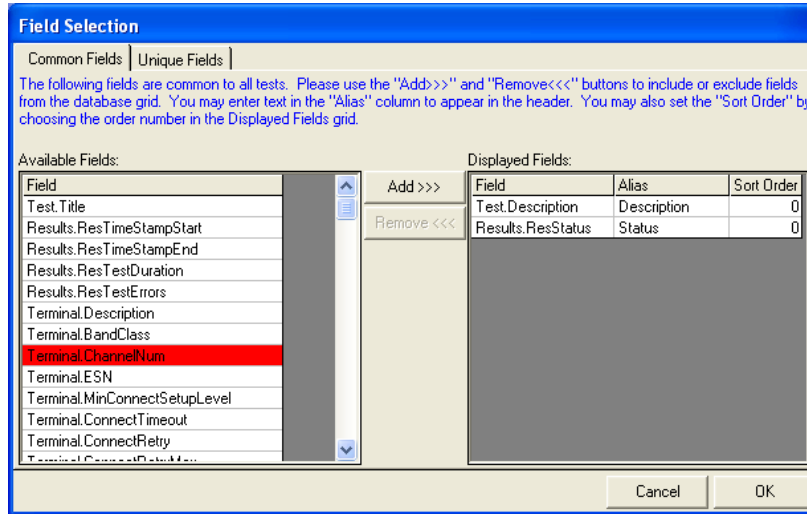


Figure 4-19: Field Selection Window

Data fields are separated by Common Fields, or Unique Fields. View these fields by selecting the appropriate tab in the *Field Selection* window.

To include common fields in the database grid, click the row in the **Available Fields** grid. The selected row is highlighted in red. Then, click the **Add** button to add the field to the end of the **Displayed Fields** grid.

If a field is selected in the **Displayed Fields** grid, the **Add** button becomes the **Insert** button. Clicking the **Insert** button inserts the field from the **Available Fields** to **Displayed Fields** by creating a new row in the grid just before the highlighted row.

To remove a field from the database grid, click on the row in the **Displayed Fields** grid and click the **Remove** button. This removes the field from the **Displayed Fields** grid and adds it to the end of the **Available Fields** grid.

The *Field Selection* window with the **Unique Fields** folder tab selected is shown in Figure 4-20.

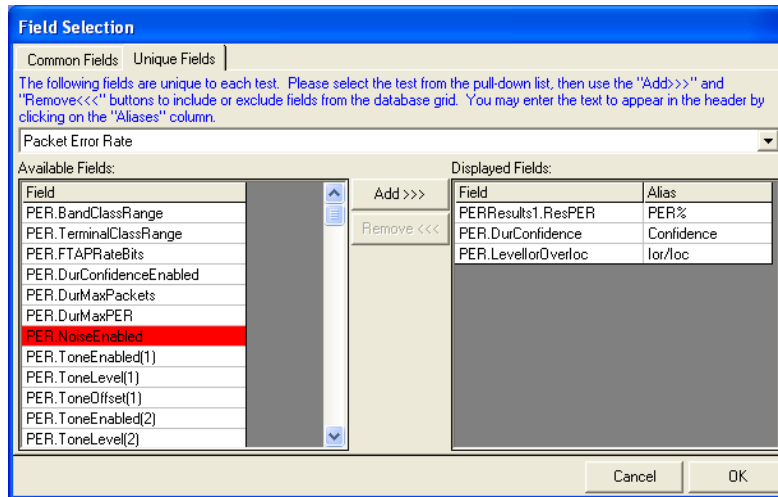


Figure 4-20: Field Selection Window – Unique Fields Tab

The *Unique Fields* folder tab works exactly the same way as the Common Fields tab, except that the test type must be selected from the pull-down list. Since unique fields are unique to a specific test, you must select the test before the fields are shown.

4.11.3. Common Fields vs. Unique Fields

Common fields are data fields that are common to all test types. For example, all tests have a description, therefore the Description field is a common field. Unique fields are data fields that are unique to one or more (but not all) test types. For example, DurMaxPER is a field that is unique to the Packet Error Rate Test.

Common fields always appear in the leftmost columns in the database grid in the order that they are selected in the **Displayed Fields** grid. Once the common fields are displayed in the grid, the unique fields display in the remaining rightmost columns.

The Sort Order for common fields can be specified in the **Displayed Fields** grid by selecting the order number from the pull down list in the grid. Tests will be sorted according to the field but within a given test type. For example, sorting by **ResTimeStampStart** sorts the tests within a given test type to the order in which they began executing. Sorting can only be done by common fields.

4.11.4. Report Restrictions

Some of the less commonly used report restrictions can be accessed in the Report Restrictions window by choosing **Options>Report Restrictions**. The common restrictions (Test Type, Hardware ID, Passed, Failed, and Undetermined) are contained on the toolbar. The Report Restrictions window is shown below.

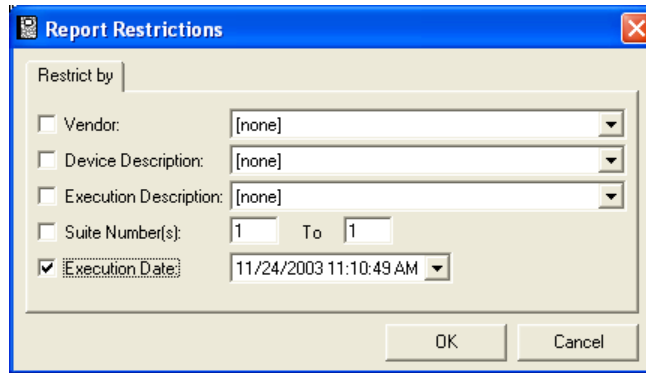


Figure 4-21: Report Restrictions Window

This window allows you to restrict the data to relevant Vendor, Device Description, Execution Description, Suite Number(s), and/or Date(s). Check the checkbox next to the desired restriction, and choose the specific item from the list to achieve the restriction.

4.11.5. Software Options

Further options can be selected in the Software Options window by selecting Options> Software Options. The *Software Options* window is shown in Figure 4-22.

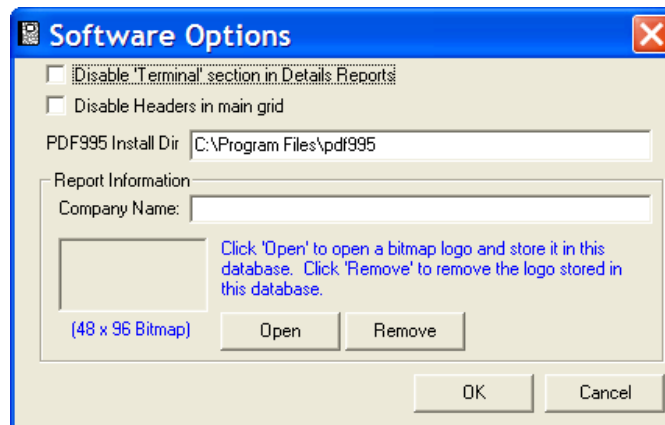


Figure 4-22: Software Options Window

The **Disable 'Terminal' section in Details Reports** checkbox hides the Terminal section in the details reports. The Terminal section can be repetitive if the same Terminal is used over a large number of tests.

The **Disable Headers in main grid** checkbox hides the gray column headers in the database grid.

The **PDF995 Install Dir** specifies the install location of the PDF995 software. This software is used to present the reports in PDF format.

4.11.6. Customizing Reports with a Company Name and Logo

Reports can be customized by embedding a logo bitmap and company name in the database. The logo bitmap appears in the upper left corner of each page in a report, and the company name appears in the lower left corner of each page in a report. To select a logo, click the **Open** button and select a **.bmp** file. The ideal logo bitmap is 96 pixels in width by 48 pixels in height. Bitmaps larger or smaller than 48x96 are re-sized. To remove a logo from the database, click the **Remove** button. Click **OK** to store the options in the database. Click **Cancel** to abandon any changes to the database.

4.12. Report Types

There are three types of reporting tools available in the EV-DO Database Viewer:

Selected Fields Report , **All Parameters and Results Report** , and **Test Errors Report** 

4.12.1. Report Type Selection Window

You can generate the **All Parameters and Results Report** when viewing **All** test types in the EV-DO Database Viewer main screen, but you must select the specific report type. The image below shows the Report Type Selection Window. Once the report type is selected from the list, click **OK** to generate the report.

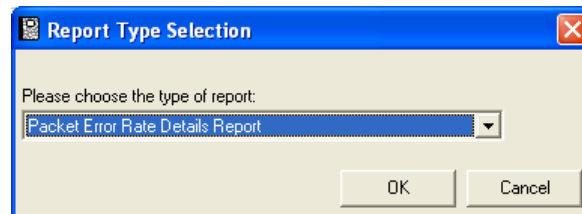


Figure 4-23: Report Type Selection Window

4.12.2. Selected Fields Report

The Selected Fields report gives information on the fields that you have selected: one field per column, one test per row. The database grid shown in Section 4.8, **EV-DO Database Viewer** is shown here as an example.

Description	Status	PER%	Confidence	Ior/Ioc
3.1.1.2.1 Demod. of Forward Traffic - Test 1	Passed	0.4	95	15.4
3.1.1.2.1 Demod. of Forward Traffic - Test 2	Passed	0.4	95	13.4
3.1.1.2.1 Demod. of Forward Traffic - Test 3	Passed	0.4	95	10.8
3.1.1.2.1 Demod. of Forward Traffic - Test 4	Passed	0.4	95	10.1
3.1.1.2.1 Demod. of Forward Traffic - Test 5	Passed	0.4	95	5.9
3.1.1.2.1 Demod. of Forward Traffic - Test 6	Passed	0.4	95	5.9
3.1.1.2.1 Demod. of Forward Traffic - Test 7	Passed	0.4	95	6
3.1.1.2.1 Demod. of Forward Traffic - Test 8	Passed	0.4	95	3.1
3.1.1.2.1 Demod. of Forward Traffic - Test 9	Passed	0.4	95	3.2
3.1.1.2.1 Demod. of Forward Traffic - Test 10	Passed	0.4	95	3.2
3.1.1.2.1 Demod. of Forward Traffic - Test 11	Passed	0.4	95	5.5
3.1.1.2.1 Demod. of Forward Traffic - Test 12	Passed	0.4	95	0.5
3.1.1.2.1 Demod. of Forward Traffic - Test 13	Passed	0.4	95	-2.5
3.1.1.2.1 Demod. of Forward Traffic - Test 14	Passed	0.4	95	0.6
3.1.1.2.1 Demod. of Forward Traffic - Test 15	Passed	0.4	95	0.7
3.1.1.2.1 Demod. of Forward Traffic - Test 16	Passed	0.4	95	0.8
3.1.1.2.1 Demod. of Forward Traffic - Test 17	Passed	0.4	95	-2.5
3.1.1.2.1 Demod. of Forward Traffic - Test 18	Passed	0.4	95	-5.6
3.1.1.2.1 Demod. of Forward Traffic - Test 19	Passed	0.4	95	-8.6
3.1.1.2.1 Demod. of Forward Traffic - Test 20	Passed	0.4	95	-11.4

Figure 4-24: Field Report Print Preview Window

The column widths of the database grid determine the column widths of this report. There are times when the number of columns causes the data to spill completely across the page and on to another page. When this happens, the “Page X of X” label will become “Page X,Y of X,Y.” Where X is the vertical page number and Y is the horizontal page number.

Click the button to advance to the next page. Click the button to go back to the previous page. Click the **Print** button to print the pages to the Windows default printer. Click the **Close** button to close the report.

4.12.3. All Parameters and Results Report

The **All Parameters and Results Report** shows all the test parameters and results for a given test. One or more report pages are devoted to each test. Figure 4-25 shows an example of the first page of the printed report.

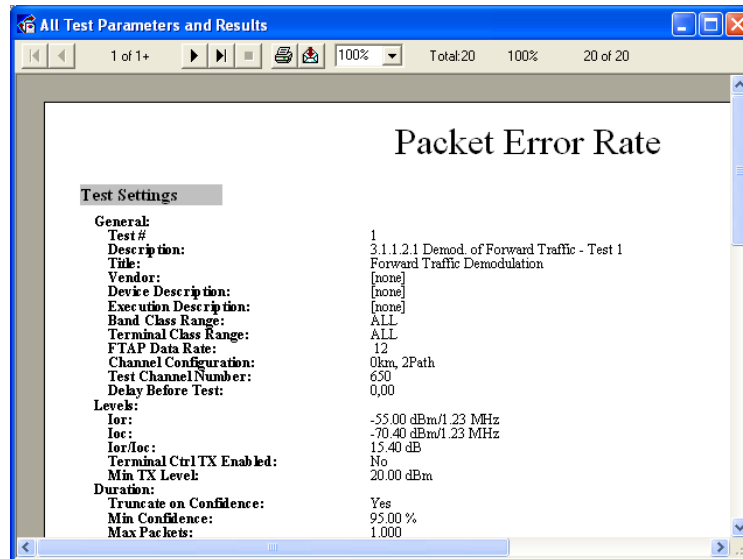


Figure 4-25: Test Parameters and Results Report Window

4.12.4. Single Page Report

Generate a Single Page report on a test by selecting the line for the test in the Database Viewer main screen. The image shown below shows the EV-DO Database Viewer main screen with a line selected. Clicking on the **All Parameters and Results Report** button generates a report for that single test. This is useful for recalling the details of a failed test, as shown.

Clicking on the line a second time unselects it. If no single test is selected, clicking on the **All Parameters and Results Report** button generates the report for all the tests in the main grid.

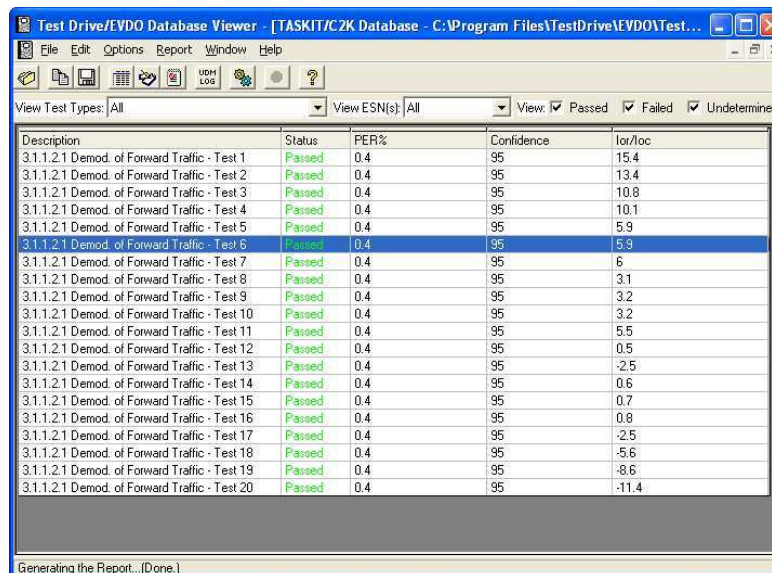


Figure 4-26: Selecting a Test

All reports that are generated display on the PC screen. Control icons for the displayed report are described below in the order that they appear at the top of the display.



Move to page 1 of the report



Move to the previous page of the report

1 of 1 The current page number of the total number of pages



Stop the generation of the report



Move to the next page of the report



Move to the last page of the report



Print the report



Export the report to a file in a user selected format such as Excel, MS Word, etc.



Select the size of the page displayed.

Total: 36 Number of tests that meet the search criteria

100% Amount of report that has completed loading

36 of 36 Number of tests that meet the search criteria of total number of test in the database

4.13.Security Features

TestDrive EV-DO uses a security mechanism that controls access to specific software functionality. This security mechanism includes attaching a hardware key (Refer to Section 2.3.4, **Copy Protection**) to the TestDrive EV-DO Controller PC and entering a password within the TestDrive EV-DO application software.

4.13.1. Entering a Password

A unique password is needed to unlock specific software functionality in TestDrive EV-DO. After installing TestDrive EV-DO for the first time, or when unlocking new software functionality, you must enter the unique password into the software application. To enter the password into TestDrive EV-DO, click the **Help** menu and select **Enter Password**. Enter the provided password into the text box and click **OK**.

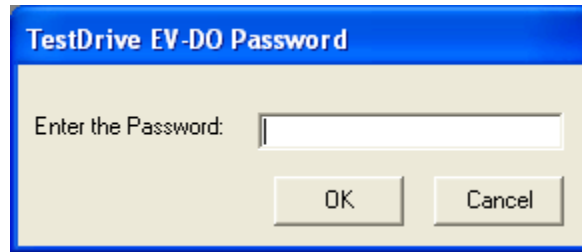


Figure 4-27: EV-DO Password Window

4.14. TestDrive EV-DO API

The API (Application Programming Interface) feature of TestDrive EV-DO provides remote control of the basic features of the application. This enables you to develop software around the standard TestDrive EV-DO test executive.

NOTE: A sample project developed in Visual Basic 6.0 is installed with TestDrive EV-DO (e.g. C:\Program Files\TestDrive\EV-DO\API Sample\). This project provides an example of how to use the API feature of the application.

The TestDrive EV-DO API is deployed as a COM Dynamic Link Library (DLL). This library (EV-DORemote.DLL) is installed with TestDrive EV-DO. The interface to this DLL exposes a single public class (EV-DOAPI) that contains the properties, methods, and events outlined below.

Once you have created an instance of the EV-DOAPI class, the TestDrive EV-DO test executive automatically opens. This allows you to have the ability to view the progress of running tests. While the API controls the TestDrive EV-DO, it is in remote mode, where most of the functionality is disabled. However, a limited set of features remain available in remote mode, such as the ability to halt or pause tests. TestDrive EV-DO is returned to local mode (full functionality) once the EV-DOAPI object has been released.

4.14.1. API Properties

CurrentTerminal

Data Type: String

Default Value: Last set mobile file in TestDrive EV-DO test executive

Description: This property corresponds to the location of the current terminal file that will be used to run a suite of tests in TestDrive EV-DO. This is the remote equivalent of selecting Current Terminal on the right side of the toolbar in the TestDrive EV-DO user interface. When this property is not set remotely, it will maintain the location of the last current terminal file set.

DatabaseLocation

Data Type: String

Default Value: Location of results database of last test run

Description: This property corresponds to the location of the TestDrive EV-DO results database. This is the remote equivalent of setting the location of the database when a suite file is to be executed. When this property is not set remotely, it maintains the location of the last database file used.

AppendToDatabase

Data Type: Boolean

Default Value: Last setting used in TestDrive EV-DO

Description: Use this property to specify whether the results of the tests to be run are appended to the currently selected database or whether the currently selected database is cleared when the next test is run. When this property is not set remotely, it maintains the last setting used.

RemoteMode

Data Type: Boolean

Default Value: None

Description: Use this property to switch TestDrive EV-DO in and out of “remote mode”. If set to False, remote mode operation is disabled and the user interface of the main application becomes interactive. If set to True, most of the UI is disabled and is only available through the remote application.

MobilePreferredMode

Data Type: string

Default Value: None

Description: Use this property to set the device to a particular technology (“CDMA”, “EV-DO” and “HYBRID” (cdma or EV-DO)). It relies upon the device driver to set the service mode.

ExecutionHalted

Data Type: boolean

Default Value: None

Description: Use this property to check whether TestDrive EV-DO is presently performing any operation. (True implies the application is idle)

HardwareStatus

Data Type: boolean

Default Value: None

Description: Use this property to check whether TestDrive EV-DO has connected and initialized the instruments. True implies that certain instrument methods can be used without explicit initialization sequences.

FLOEnabled

Data Type: boolean

Default Value: None

Description: Sets an indicator to whether a FLO system is actively controlling TestDrive EV-DO

maxTests

Data Type: integer

Default Value: 256

Description: Returns the hard-coded limit for the maximum tests that can be present in a suite.

testTitle

Return Data Type: string

Input Data type : long

Default Value: none

Description: After a suite is loaded, this property can be used to retrieve the title of the nth test in the suite, where n is the input to the property.

testDescription

Return Data Type: string

Input Data type : long

Default Value: none

Description: After a suite is loaded, this property can be used to retrieve the description of the nth test in the suite, where n is the input to the property.

4.14.2. API Methods

RunSuite

Inputs: SuitePath – a string that specifies the location of the suite file to be run

Outputs: None

Description: This method loads and executes the suite file specified as input. It uses the mobile file determined by the CurrentMobile property and logs the results to the database determined by the DatabaseLocation property. When using this method, RunSuite acts as a blocking function and holds control until the suite has completed executing or an error has occurred. The API will provide updates of the current status of the running suite through the ProgressUpdate event. Since the TestDrive EV-DO test executive is running in the background, the progress of the running suite can also be viewed or halted by switching over to the application.

StopExecution

Inputs: None

Outputs: None

Description: This method halts any currently executing suites. Since the RunSuite method acts as blocking function, you can use this method while handing the ProgressUpdate event to stop execution of the suite.

ExitEV-DO

Inputs: None

Outputs: None

Description: This method halts any currently executing suites. Then disconnects from the instruments and terminates the TestDrive EV-DO application.

PauseExec

Inputs: None

Outputs: None

Description: This method pauses any executing suite.

ResumeExec

Inputs: None

Outputs: None

Description: This method resumes a paused suite.

Get8960Applications

Inputs: None

Outputs: String

Description: This method returns the available Agilent 8960 applications as a “,” separated string.

Get8960ApplicationRevs

Inputs: string

Outputs: String

Description: This method returns the available Agilent 8960 application revisions for a given application, as a “,” separated string. The application name has to be a valid sub-string from the return value of Get8960Applications

Get8960ApplicationDetails

Inputs: None

Outputs: String

Description: This method returns the currently executing Agilent 8960 application in the format (application name, application revision)

Set8960ApplicationDetails

Inputs: String

Outputs: Boolean

Description: This method sets the currently executing Agilent 8960 application. The input is in the format (application name, application revision). Note that 8960 takes almost 3-5 minutes to switch to a different application.

ValidateTest

Inputs: sSuitePath As String, testNumber As Long

Outputs: Boolean

Description: This method validates the specified test from the specified suite.

ValidateSuite

Inputs: sSuitePath As String

Outputs: Boolean

Description: This method validates all the test in the specified suite.

ExecuteTest

Inputs: sSuitePath As String, testNumber As Long

Outputs: Boolean

Description: This method executes the specified test from the specified suite.

ExecuteSuite

Inputs: sSuitePath As String

Outputs: Boolean

Description: This method executes all the tests from the specified suite.

4.14.3. API Events

SuiteComplete

Outputs: None

Description: TestDrive EV-DO fires this event whenever execution of a suite is completed. After this event is fired, you can run more suites or analyze results from the completed suite execution.

ProgressUpdate

Outputs: Status – a string representing the current action being performed by the TestDrive EV-DO test executive

Description: The TestDrive EV-DO software will fire this event frequently during the execution of a suite of tests. It provides information of the current execution steps being performed by the software.

Error

Outputs: Error Message – a string describing the error that occurred.

Description: The TestDrive EV-DO software fires this event when an error occurs in the course of the suite execution. Non- critical errors result in the software continuing on to the next test in the suite. If a critical error results in the termination of suite execution the SuiteComplete event is also fired.

4.15. Multi-application Remote API

4.15.1. Overview

The TestDrive Remote Client is a utility used to control TASKIT C2K, TestDrive EV-DO, and TASKIT PLTS systems at the same time. The Client window is shown in Figure 4-28. The client allows you to configure the different applications, and configure long-running automated sessions.

The utility manages all overhead tasks when switching from one system to another, for example, when switching from a C2K test suite to an EV-DO suite, the utility automatically switches the base station application to EV-DO, the mobile to EV-DO only mode, sets the appropriate terminal file, database, etc. Without this utility, you would have to monitor the C2K system to finish execution, and manually perform these actions before executing the EV-DO system.

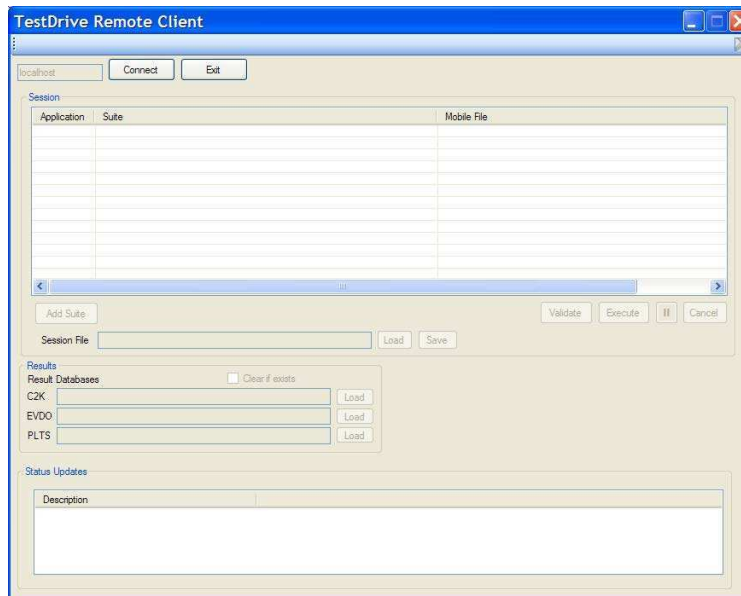


Figure 4-28. TestDrive Remote Client Window

4.15.2. Requirements

- VB .NET module on the controller PC. This utility was developed on the .NET framework and requires a .NET module on the host system. When the application is executed, it checks for this module and prompts for installation, if needed.
- Spirent Super-Rack; or a Spirent system capable of executing C2K, PLTS, and EV-DO test suites.

This system normally consists of: Agilent 8960, 3460/3462, 3452, 5500, TCU, Agilent 3499, Agilent Spectrum Analyzer, and TAS 3710 PDE, GSS 5060/6560. The host PC should contain the latest versions of applications that support this utility. Software versions prior to C2K 5.30, EV-DO 4.30 and PLTS 3.10 do not offer support.

- The mobile device driver needs to support functionality to switch the device between CDMA service only, EV-DO service only and Hybrid modes (CDMA or EV-DO).

4.15.3. Features and General Usage

1. Start the Server. The *Command* window displays, as shown in Figure 4-29.

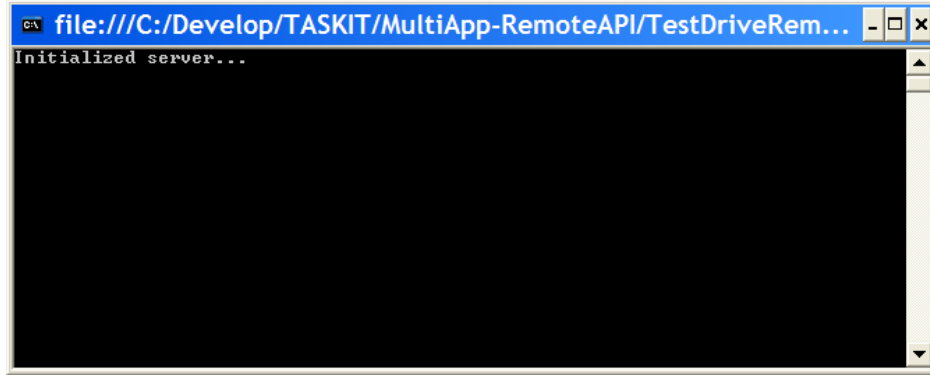


Figure 4-29 Server Initialization Window

2. Start the Client. The *TestDrive Data Client* window displays, as shown in Figure 4-28.
3. Connect the client to the server by clicking the **Connect** button.
After connecting to the server, the utility reads an initialization file (**MSF.ini**)
You are notified if there is a problem with initialization

NOTE: Using the default INI file is not mandatory. We recommend you go through the initialization procedure when using the software for and after any upgrades to the Agilent 8960.

4. Add a suite by clicking the **Add Suite** button.
The utility reads the suite prompts for the appropriate device file (.mob for C2K, .ter for EV-DO and .mob for PLTS).

NOTE: The PLTS device file is different from the C2K mobile file, even though they have the same extension (.mob).

5. As suites are added, they are grouped according to the application.
Change the order of execution by clicking the **Application** header in the Suite window.
6. Update the Result databases for the appropriate applications.
7. Save the Session settings by clicking the **Save Session File** button.
8. Validate or Execute the session.
Validation is recommended to verify the Application Settings (instrument configuration, software settings), and Device File Settings (especially com port setting) are correct.
9. Verify the settings by clicking the **Configuration** button.
The *System Configuration* window displays, as shown in Figure 4-30.

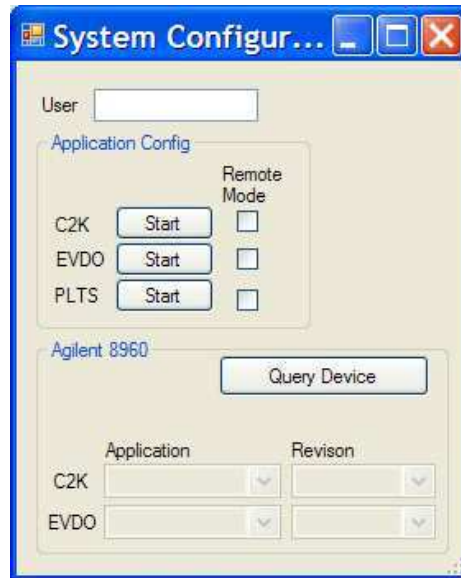


Figure 4-30 System Configuration Window

10. The System Configuration window allows you to configure and verify individual application settings.
For example, to verify C2K settings, click the **Start** button next to C2K application, disable **Remote Mode**, and configure the C2K settings using the *TASKIT C2K GUI*.

NOTE: When you load a Device file in the utility, only the path is noted. The file contents can still be changed.

11. When changing from C2K to EV-DO, you must set the base station to the appropriate application.
12. Select the application using the **Agilent 8960** settings in the *System Configuration* window, as shown in Figure 4-30.
You must start either C2K or EV-DO before the 8960 displays the available applications.
13. Click the **Query Device** to query the 8960.
Available C2K and EV-DO choices are populated and you can set the preferred application.
This step is necessary after upgrading the 8960, or using a different system.
These settings are stored in the **MSF.ini** file and loaded automatically when the application is started.
14. After completing System Configuration, proceed to executing the session.

NOTE: The system will stop and prompt for user-assisted tests and system failures.

4.16. Email Notification

4.16.1. Overview

This feature enables automated email notification. The Email Notification allows you to have emails sent about events occurring in EV-DO. To set up Email Notifications, select **Config>Email Notification**. The *Email Notification* window displays, as shown in Figure 4-31.

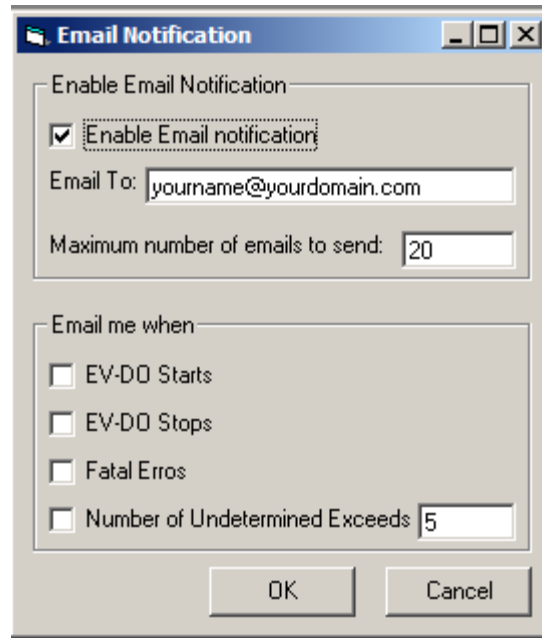


Figure 4-31: Email Notification Window

You can set the following parameters in the *Email Notification* window:

- Enable Email Notification:**
 This parameter allows you to enable or disable email notification. By default, email notification is disabled.
- Email To:**
 This parameter allows you to specify an email address. Separate multiple email addresses with semi-colons.
- Maximum number of emails to send:**
 This parameter limits the number of emails sent for a given run of EV-DO. While running a session, EV-DO resets this parameter at the session level. When running a suite, EV-DO resets this parameter at the suite level.
- EV-DO Starts:**
 Sends an email when EV-DO starts. With this option, Email Notification needs to be enabled.
- EV-DO Stops:**
 Sends an email when EV-DO stops. With this option, Email Notification needs to be enabled.

- **Fatal Errors:**
Sends an email when there are fatal errors. These include; failure to connect to instruments, mobile failed to register, and failure to connect to UDM. With this option, Email Notification needs to be enabled.
- **Number of Undetermined Exceeds:**
Sends an email when the number of undetermined test results exceeds the specified limit. With this option, Email Notification needs to be enabled.

4.16.2. Requirements

You are required to configure the IIS SMTP Virtual Server on the machine running TestDrive EV-DO.

To configure the IIS SMTP Virtual Server:

1. Select **Start>Control Panel**.
2. Under **Administrative Tools**, open **Internet Information Services**.
3. Under the left pane in the *Internet Information Services* window, right-click **Default SMTP Virtual Server** and select **Properties**.
4. The *Default SMTP Virtual Server Properties* window displays.
Select the *Delivery* tab and click **Outbound Security**.
5. Under *Outbound Security*, select **Integrated Windows Authentication**, enter a valid username and password and click **OK**.
6. Under the *Delivery* tab, click the **Advanced** button.
7. The *Advanced Delivery Options* window displays.
Enter the name of your email server for Smart Host and click **OK**.
To use the IP Address instead of the server name, enter it in square brackets “[]” to tell Windows to look for an IP Address during the DNS Look-up.
Note that DNS Look-up is an expensive operation.
8. Under the *Delivery* tab, click the **Apply** button, and then click **OK**.
9. The SMTP Virtual Server Configuration is now complete.

5. Troubleshooting EV-DO ATS

5.1. Overview

The following section is a reference guide for troubleshooting problems with test execution.

EV-DO ATS is designed to make testing Access Terminal devices as simple as possible. However, as with any complex system, it is possible to encounter difficulty when using EV-DO ATS. This section provides useful information to troubleshoot such difficulty.

EV-DO ATS has a diagnostic utility built into the TestDrive EV-DO software. This feature can evaluate the current RF cabling to determine if the system has been cabled correctly. It also determines if the instruments can be controlled via GPIB. There is additional information in this chapter regarding errors that occur while validating and executing a test suite.

Although a test suite may execute properly, the actual results may look incorrect. A separate section of this chapter addresses such unexpected results. Finally, a list of frequently asked questions (FAQs) and their associated answers appear at the end of this chapter.

5.2. System Diagnostics

The TestDrive EV-DO System Diagnostic procedure is a useful tool for debugging system level problems such as, incorrect software configuration, incorrect control or RF cable configuration, and malfunctioning equipment.

This procedure is not meant for performing calibration of system hardware. If any of the Spirent hardware needs to be calibrated, refer to the User Manual for the specific instrument.

If the diagnostics procedure fails, a debug tool (refer to Section 5.2.3 on page 88 for more details) is located in the *Utilities* subfolder where the TestDrive EV-DO application is installed. The default location is: **C:\Program Files\TestDrive\EV-DO\Utilities**.

This folder can also be used to troubleshoot other diagnostic failures.

5.2.1. Instrument Requirements

The following instruments must be installed in the system to execute this procedure:

- Agilent 8960 (one to three)
- Agilent ESA series Spectrum Analyzer
- SR3452 V2 CDMA Network Emulator (two)
- SR3462 EV-DO Network Emulator
- Agilent 3499, TAS5408 and SR5068 Test Configuration Units
- GPIB and RF cables includes in the TCU-KIT.

Additionally, the TestDrive EV-DO System tests the following optional equipment if connected to your system:

- Spirent SR5500 Wireless Channel Emulator
- ESG4438B Signal Generators (two)

5.2.2. Diagnostic Procedures

Prior to executing this procedure, ensure your system is configured as outlined in the *Rack Setup Guide*.

To execute the diagnostic procedure, select **Execute>System Diagnostics**, and then click the **Run** button.

The *EV-DO Diagnostic Procedure* window displays while the diagnostic procedure is executing, as shown in Figure 5-1.

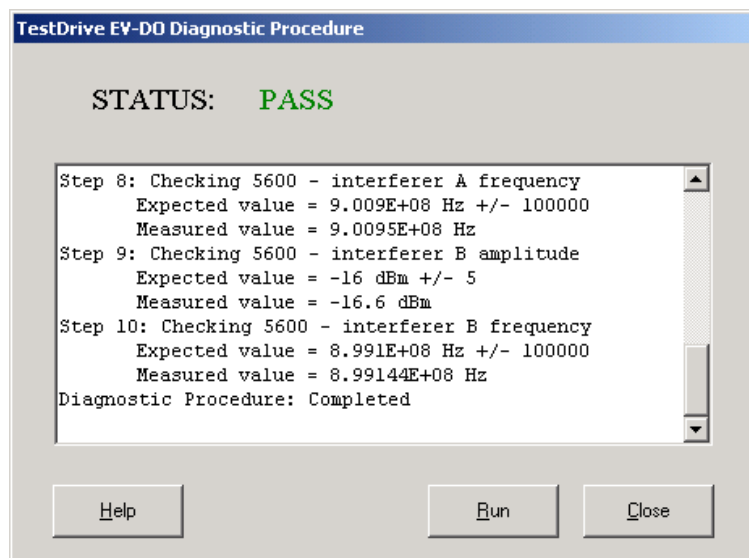


Figure 5-1: EV-DO Diagnostic Procedure Window

The following steps describe the functions performed when the System Diagnostic procedure is executed. If you detect errors while the procedure is executing, the software displays a list of possible causes in a message box. Additionally, these descriptions are documented below for convenience.

Step 0 – Initializing HW

This procedure attempts to communicate with all required system hardware. If TestDrive EV-DO software or any control cables are incorrectly configured, it is detected by this test. If this test fails, the most likely causes are:

- Required instrument HW is not enabled. Check the ‘Communications’ settings from the ‘Software’ menu.
- Incorrect GPIB addresses have been selected. Verify that ‘Communications’ setting in the ‘Software’ menu match the instrument configurations. Each instrument should have a unique GPIB address.
- GPIB cables have not been properly connected to one or more instruments.
- One or more instruments have not been powered on.
- GPIB card has not been installed/configured correctly in the test PC.

Steps 1&2 – Checking 8960

This procedure verifies the RF generator in the Agilent 8960 and the measurement capability of the Spectrum Analyzer. Additionally it verifies that the Agilent 3499, TAS5048 and SR5068 are working, and that some of the RF cables have been correctly configured. If this test fails, the most likely causes are:

- Power has not been applied to the TAS5048 or SR5068. This can be verified by checking the green status LED on the front panel.
- The custom control cable is not securely connected from the Agilent 3499 to the TAS5048.
- Cable C3 is not securely connected from the Agilent 8960 RF IN/OUT port to the TAS5048 P3 port.
- Cable C1 is not securely connected from the Spectrum Analyzer RF IN port to the TAS5048 P1 port.

Additionally it is possible that one of the following instruments is malfunctioning: Agilent 8960, Agilent 3499, TAS5048, SR5068 or Agilent Spectrum Analyzer

Up to two auxiliary Agilent 8960 units are checked in this step if Rev. B protocol tests are permit.

Step 3 – Checking the Channel Emulator Auto Range

This procedure verifies the SR5500 is receiving a signal at the appropriate level and can perform an auto-range function. If this test fails, the following are the most likely causes:

- Cable C5 is not securely connected from the SR5500 Channel #1 IN port to the TAS5048 P5 port.

Additionally it is possible that one of the following instruments is malfunctioning:

TAS5048, SR5068 and Agilent 3499A

Step 4 – Checking Channel Emulator Output Level

This procedure verifies the SR5500 Channel #1 main signal path is operational. If this test fails, the following are the most likely causes:

- Cable C10 is not securely connected from the SR5500 Channel #1 OUT port to the SR5068 P3 port.
- There is no loopback cable connected from the SR5500 Channel #1 LO OUT to Channel #1 LO IN.

Step 5 – Checking Channel Emulator Bypass Level

This procedure verifies the SR5500 Channel #1 Bypass feature is working properly. If this test fails, the following are the most likely causes:

- SR5500 may be operating out of spec.

Step 6 – Checking Channel Emulator Channel 1 with AMP

This procedure verifies the SR5500 and amplifier in the path is working properly. If this test fails, the following are the most likely causes:

- SR5500 may be operating out of spec.
- Amplifier may be malfunctioning.

Step 7 – Checking Channel Emulator Channel 2 output level in Diversity Mode

This procedure verifies the SR5500 in diversity mode is working properly. If this test fails, the following are the most likely causes:

- SR5500 Diversity Mode may be operating out of spec.

Step 8– Checking Channel Emulator Channel 2 output level in Diversity Mode with amplifier

This procedure verifies the SR5500 in the diversity path with amplifier is working properly.

Steps 9-19 are no longer necessary.

Steps 20 & 21 – Checking ESG #1 Output Amplitude and Frequency

This procedure verifies that the ESG #1 is working properly. If this test fails, the following are the most likely causes:

- Cable C7 is not securely connected to the 1U Filler Panel P2 port.
- Cable C22 is not securely connected to the SR5068 P11 port

Steps 22 & 23 – Checking ESG #2 Output Amplitude and Frequency

This procedure verifies that the ESG #2 is working properly. If this test fails, the following are the most likely causes:

- Cable C8 is not securely connected to the 1U Filler Panel P1 port.

- Cable C21 is not securely connected to the SR5068 P13 port.

Steps 24 - 27– Checking ESG #1 Output Amplitude and Frequency I with amplifiers in the path

This procedure verifies that the AirAccess channel 1 is working properly. If this test fails, the following are the most likely causes:

- Cable C7 is not securely connected to the SR5068 P7 port.

Step 28– Checking AA Channel 1 output level

This procedure verifies that the AirAccess channel 1 is working properly. If this test fails, the following are the most likely causes:

- Cable C16 is not securely connected to the SR5500 channel2 input.

Step 29– Checking Channel Emulator channel 2 auto-range

This procedure verifies that the channel emulator channel 2 is working properly. If this test fails, the following are the most likely causes:

- Channel Emulator channel 2 auto-range function may not work properly.

Step 30– Checking AA Channel 2 output level

This procedure verifies that the AirAccess channel 2 is working properly. If this test fails, the following are the most likely causes:

- Cable C16 is not securely connected to the SR5500 channel2 input.

Step 31– Checking Channel Emulator channel 2 Bypass mode

This procedure verifies that the channel emulator channel 2 is working properly in bypass mode.

Step 32– Checking Channel Emulator channel 2 output level with an amplifier

This procedure verifies that the channel emulator channel 2 with an amplifier in the path is working properly.

5.2.3. Diagnostic Debugger

The Diagnostic Debugger supports both C2K-ATS and EV-DO TestDrive systems, up to the latest release. If any step after Initialization fails, start the Diagnostics Debugger by opening the **C2K_Diag_Debug.exe** file. During the process, leave the C2K and/or EV-DO Executive windows open.

An “N-type” female-female connector and a torque wrench are needed to change cable connections.

After opening the **C2K_Diag_Debug.exe** file, the *Diagnostic Debugger* window displays, as shown in Figure 5-2.

The following sections of the *Diagnostics Debugger* window are the most relevant for debugging a failed diagnostic process:

- **Instruction Pane** – This pane is located in the upper section of the window. The pane allows you to set Instrument Parameters, Re-cable Connections, and set measurements. The settings prior to debugging are shown in the Instruction Pane when the debugger starts.
- **Debug Steps** – This menu displays in the upper-right corner of the window. Select the diagnostic step that failed from the pull-down menu to view the steps.
- **Connect Button** – This button is in the upper-left section of the window. Before debugging, the Diagnostics Debugger must be connected to the system.
- **Switch Position Panels** – These two panels are located in the lower-left section of the window. There are eight (8) switches for SR5048 and six (6) switches for SR5068. Set the two positions of each switch by clicking the **Position One** or **Position Two** button.
- **SR5048 Configuration and SR5068 Configuration** – These menus are located under the Instruction Panel. Select the standard paths determined by the switches of the SR5048 and SR5068 from these menus.

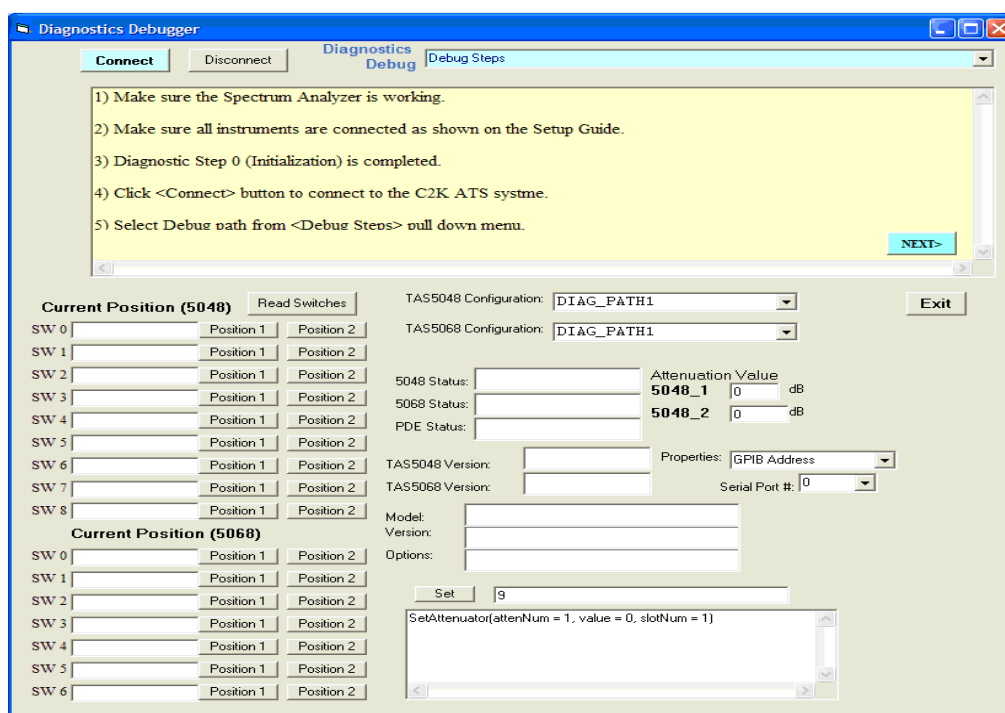


Figure 5-2: Diagnostics Debugger Window

After connecting to the system, select the failed debug step from the **Debug Steps** menu, and follow the instructions given in the *Instruction Pane*. Note that the steps are shown in the chronological order. For example, in any chosen step, we assume that the diagnostic steps have passed successfully.

Most diagnostics failures require more than one step to debug them. This is the reason multiple debug paths and instructions are shown in the *Instruction Pane* for each Debug Step.

The switch connections in the SR5048 and SR5068 paths are set by the debugger after selecting a debug step. To reset the diagnostic path manually, select the path from the **TAS5048 Configuration** and **TAS5068 Configuration** menus.

Click the **NEXT** button to proceed to the next step in the debugging procedure.

Make sure to reconnect the cables as shown in **Setup Guide** before beginning to debug another diagnostics path.

5.3. Test Validation Errors

The **Validate Suite** function from the Execute Menu examines the test parameters in the suite. This operation can significantly reduce the risk of problems during test execution by detecting parameter conflicts beforehand. Some of the errors that could occur during suite validation are listed below:

Insufficient hardware for test; [Instrument] not detected.

The indicated instrument is required to run the test, but was not found. Make sure the indicated instrument is on the GPIB bus, set to present in the Communications window, and set to the correct GPIB address.

Insufficient hardware for noise and tone simulation simultaneously.

If both noise and interfering tones are selected as impairments, this error will be generated during suite validation. Both impairments cannot be selected simultaneously.

Insufficient hardware fader requires noise to be present; Fader not detected.

If fading is enabled for a test, the SR5500 must be present for the test to execute.

Parameter out of range.

Parameters are checked against a maximum range when entered in the Test Settings grid. Some parameters have ranges that are affected by the ranges of other parameters. Therefore, setting a value for a related parameter could cause the other parameter to be out of range. This error is generated as a result.

5.4. Test Execution Errors

While a suite is executing, execution errors are listed in a grid in the TestDrive EV-DO suite window. View the errors by clicking the test execution button in the results area (lower right) of the suite window. Each line in the grid represents a single error. For each error, the test number, error number, and description are listed.

This section elaborates on the condition for specific test execution errors and gives helpful information to resolve the error. Note that TestDrive EV-DO is designed to handle errors without failure. This means that if an error occurs, the test proceeds as far as possible. If a test must be skipped due to errors, its status is given as “Undetermined”. After the error is resolved, the test must be executed again to collect the results.

5.4.1. *Terminal Fails to Open a Session and or Setup Data Connections*

TestDrive EV-DO attempts to open a session between the Terminal and the Base Station Emulator at the beginning of a suite. For each test that executes TestDrive EV-DO will setup a data connection. If the Data Connection drops while a suite is executed, TestDrive EV-DO will setup the connection again.

There are many possible reasons for failure of the Terminal to open a data session or setup a data connection. The following details some of the causes and suggests ways to resolve the problem.

Cause #1: The RF Cabling in EV-DO ATS is incorrect.

Use the setup information in this manual or the quick setup poster to verify the cabling. Use the System Diagnostic feature described earlier in this chapter to ensure proper cabling.

Cause #2: There is a problem with the Terminal.

Verify the following information with regards to the Terminal:

- The Terminal is EV-DO Terminal device.
- The Terminal features an RF interface that is working correctly.
- The Terminal is powered on and has enough power to operate correctly. Is the Terminal powered by an external power supply instead of its own AC adapter or battery? Is that external power supply set correctly for the Terminal’s power interface? The Terminal may be powered on and its User Interface may operate, but the RF interface may not operate correctly if it is not powered properly.
- The Terminal is properly interfaced to EV-DO ATS. The RF connection to the Terminal device is reliable and appropriately accounted for in the Terminal correction factor in TestDrive EV-DO. Note that some RF interfaces can “wear out” with too much physical handling. Sometimes these interfaces become intermittent. To help determine such a case, adjust the physical RF connection and see if the Terminal responds.

- The Terminal device should be setup to allow roaming, so that non-home SID's and non-home channels will be allowed (searched).

Cause #3: The Terminal setup information is incorrect in TestDrive EV-DO.

Due the parameters test in the Terminal File match those required by the device under tests? Pay particular attention to the Channel Number and Band Class.

Cause #4: The Terminal does not have enough time or attempts to setup a Data Connection.

Adjust the Data Connection Setup parameters in the Terminal window to allow more retries or more time per retry (Connect timeout, Retry Delay, Number of Retries).

Cause #5: The hardware setup information is incorrect in TestDrive EV-DO.

Make sure the settings are correct in the Communications window in TestDrive EV-DO (select Communications from the Options menu). If an instrument is set to Not Present, be sure it is not in the RF cabling configuration. This can cause unpredictable results.

Cause #6: The Terminal correction information is incorrect in TestDrive EV-DO.

Use the lower half of the Terminal window to configure the Terminal correction information. TestDrive EV-DO uses this information to ensure an accurate power level reaches the Terminal.

Cause #7: The system calibration information is incorrect in TestDrive EV-DO.

Perform the System Calibration procedure to ensure the correct calibration information is in TestDrive EV-DO.

Cause #8: The incorrect Terminal file is being used in the suite.

Ensure that the correct Terminal file is being used in the suite. If you have the Terminal file open, be sure any changes are saved before the suite is executed. Use the Window menu to determine what files are open.

Cause #9: Terminal has not been configured for Subtype 2 Physical Layer. (If executing TIA/EIA-866A/C.S0033-A test cases for Subtype 2 Physical Layer)

The following pertains to handsets using Qualcomm chipsets:

In order to execute C.S0033 Rev A test case, certain NV parameters need to be configured. Using the Qualcomm NV browser, edit item 3458 to set the following:

- Custom Config – **TRUE**
- Subtype 2 Physical Layer – **1**
- Enhanced FTCMAC – **1**
- Subtype 3 RTCMAC – **1**

Edit item 4202 and set the parameter to **0**.

To ensure proper performance, verify these settings with the handset manufacturer.

Other recommendations include:

- Connect the Base Station directly to the Access terminal to eliminate suspicious hardware and verify the Terminal's configuration. Remember to configure the hardware and the software appropriately.
- Use a Terminal device that is working correctly to ensure proper EV-DO ATS operation. Remember to adjust the Terminal settings for each Terminal in use.
- The Terminal is properly isolated from outside RF (other nearby cell sites and signal sources).

5.4.2. *Impairments Too Severe for Data Connection*

This particular error represents a unique condition. In order to setup Data Connections, TestDrive EV-DO configures the RF conditions for no impairments and for a minimum signal power level. Once the connection is established, the RF conditions are modified to perform the test. After the RF conditions are modified, TestDrive EV-DO checks if the connection is still setup. If the connection is not setup, this error is generated. This implies that the Terminal is unable to correctly demodulate enough packets accurately to maintain the connection. TestDrive EV-DO will list the test status as Undetermined and proceed to the next test. Unfortunately, unless the connection can remain setup, the test cannot be performed.

5.5. Unexpected Results

This section discusses some of the reasons why variations in results may exist and can give helpful information for resolving these issues.

It is important the EV-DO ATS is setup correctly. It is a good idea to review the causes for session open and Data Connection failures earlier in this chapter. Some of the reasons for unexpected results are the same as some of the reasons for registration and call setup failure. Pay particular attention to:

- RF Cabling
- System Calibration
- Terminal Correction Factor in the Terminal window

Terminal devices are expected to perform differently under different RF conditions. For example, if the same test is performed at a different frequency, it is common to see a difference in the results. Another example is the power level at which the test is performed. It is possible to see a difference in the Spurious Response of the Terminal device when it is transmitting at a different power level.

5.6. Frequently Asked Questions

How do I change the test type in the Suite window?

It is not possible to change the test type for an existing test. You must first delete the existing test. Once the test is deleted and the space in the grid is blank, you may select a new test type.

How do I edit the parameters for a test?

While looking at the suite window you can click on the test title column on any of the rows. This will update the grid in the upper right part of the window with all settable parameters related to the test of the row on which you clicked. In general if you click or select a test, the frame to the right will be showing the settable parameters of the row (test) pertaining to the column title.

Why Do I get an error when I attempt to 'Verify Hardware'?

The Verify Hardware feature in the Communications window attempts to communicate with the remote instruments, obtain some information about them and update the information displayed in the Communications window. TestDrive EV-DO will only communicate to the instruments using GPIB. Be sure your computer is equipped with a National Instruments GPIB card and that the instruments are correctly connected to the PC using GPIB cables. Also, make sure the GPIB addresses of the instruments match the setting in the Communications window. Each instrument must have a unique GPIB address. You must do this manually at the front panel of each instrument. Be sure each instrument is powered on and ready for remote control.

Why can't I edit a value printed in blue?

Values printed in blue indicate read only parameters. You cannot change these parameters directly. Refer to specific parameters to understand how to change them or why they are read-only.

I see "Over Range" or "Under Range" errors on the 8960 front Panel, is this a problem?

This is not a problem. During the course of a suite execution TestDrive EV-DO will setup test conditions using a variety of system configurations. These changes include switching instruments in and out of the forward and reverse path. These changes will cause wide variations of path loss. Since it is not possible to simultaneously change system configurations and Base Station Emulator offsets there will be short instances where the forward and reverse path losses are not accurately specified in the base station emulator. This is when this error is displayed. The error is not automatically cleared from the screen even when the problem is resolved. Spirent engineers have spent considerable time verifying that at test execution time all levels and offset values are correct ensuring that an "over range" or "under range" condition does not really exist.